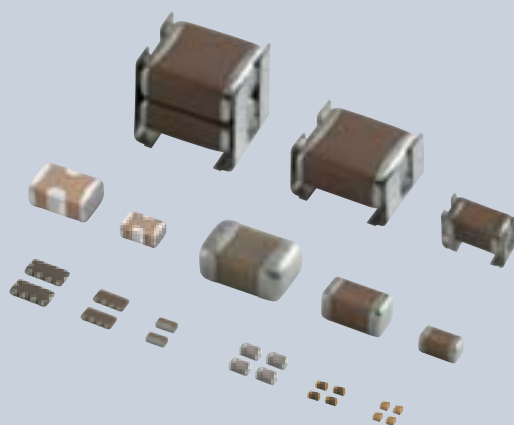


Chip Multilayer Ceramic Capacitors for General



2018

Explanation of Symbols in This Catalog

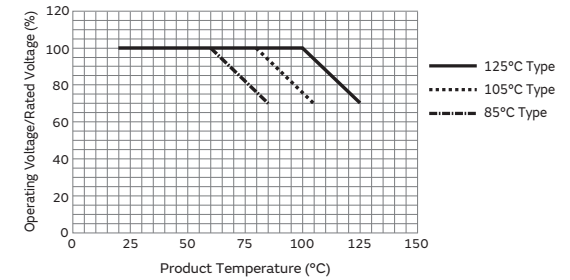


Links are provided to the latest information from the PDF version of the catalog, which is available on the web.

General	For applications that do not require the particular reliability such as the general equipment
Info-tainment	Infotainment for Automotive The product for entertainment equipment like car navigations, car audios, and body control equipment like wipers, power windows.
Powertrain	Powertrain/Safety for Automotive Product used for applications (running, turning, stopping and safety devices) which particularly concern human life, such as in devices for automobiles.
Medical Device	Medical-grade products for Implanted Medical Devices These products are intended for use in implanted medical devices such as cardiac pacemakers, cochlear implants, insulin pumps and gastric electrostimulators. They are suitable for use in non-critical circuits. *1 *1 Non-critical circuits This term refers to circuits in implanted medical devices that are not directly linked to life support, i.e. circuits that will not directly endanger the life of the patient should the functionality of the device be reduced or halted by failure of the circuit.
AEC-Q200	AEC-Q200 compliant product
Safety standard	Safety Standard Certified Product Products that acquired safety standard certification IEC60384-14 and products based on the Electrical Appliance and Material Safety Law of Japan.
Japanese Safety Law	Based on the Electrical Appliance and Material Safety Law of Japan Products that are based on the electrical appliance and material safety law of Japan.
High Q	Low dissipation for high frequency By devising ceramic materials and electrode materials, low dissipation is achieved in frequency bands of VHF, UHF and microwave or beyond.
Low ESL	Low inductance This capacitor is designed so that the parasitic inductance component (ESL) that the capacitor has on the high frequency side becomes lower.
Fail safe	Fail safe product This capacitor is designed to prevent failures as much as possible by short mode.
Deflecting crack	Product resistant to deflection cracking This capacitor is designed to prevent failures as much as possible by short mode caused by cracking when there is board deflection.
Soldering crack	Product with solder cracking suppression "This capacitor is configured with metal terminals and leads connected to the chip. The metal terminals and leads relieve the stress from expansion and contraction of the solder, to suppress solder cracking."
Anti-noise	Product suitable for acoustic noise reduction and low distortion This product suppresses acoustic noise, which occurs when a ceramic capacitor is used, by devising the materials and configuration.
Effective Cap	No DC bias characteristics Polymer capacitor is no capacitance change with DC bias due to aluminum oxidized film for dielectric.
EMI FIL®	Low-inductance product suitable for noise suppression. This product has extremely low ESL and is suitable for suppression of noise, including high frequencies. This product can also be used as a low-ESL, high-performance bypass capacitor.
Bonding	Product for bonding Since gold is used for the external electrodes, the capacitor can be mounted by die bonding/wire bonding.

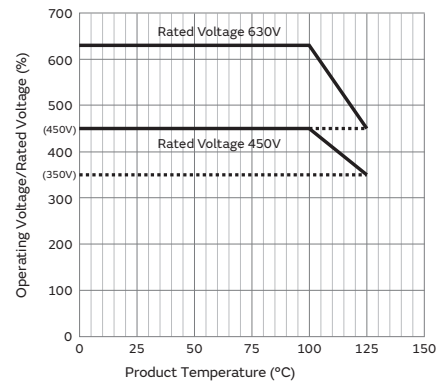
Derating 1
 This product is suitable when a voltage continuously applied to a capacitor in an operating circuit, is used below (derated) the rated voltage of the capacitor. This model guarantees the test conditions in the endurance test, at a rated voltage x 100% at the maximum operating temperature. A reliability assurance level equivalent to a common product can be secured, by using this product within the voltage and temperature derated conditions recommended in the figure below.

Recommended Conditions of the Derating Operating Voltage and Temperature



D1
 Derating 1

Derating 2
 When the product temperature exceeds 105°C, please use this product within the voltage and temperature derated conditions in the figure below.

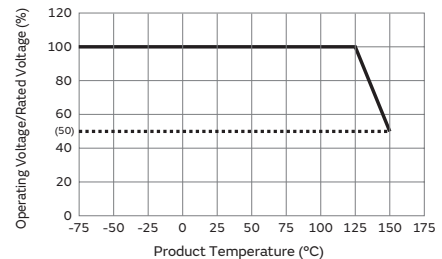


D2
 Derating 2

Derating 3
 Please apply the derating curve according to the operating temperature.
 Please refer to detailed specifications sheet for details.

D3
 Derating 3

Derating 4
 When the product temperature exceeds 125°C, please use this product within the voltage and temperature derated conditions in the figure below.



D4
 Derating 4

Derating 5
 Please apply the rated voltage derating over 150 °C.
 Please refer to detailed specifications sheet for details.

D5
 Derating 5

Selection Guide for Capacitors

For general

General SMD

Solder mounting

Chip type

	GRM		p40	
	GRM	For LCD backlight inverter circuit only		WEB
	GR3	Anti-noise	High effective capacitance & high ripple current	p109
	GRJ	Deflecting crack	Soft termination	p120
	GXM	Water Repellent		WEB
	GR4		For information devices only	p125
	GR7		For camera flash circuit only	p130
	GJM	High Q		p135
	GQM	High Q	High power	p164
	GA2	Japanese Safety Law	Based on the Electrical Appliance and Material Safety Law of Japan	p184
	GA3	Safety standard		p189
	LLL	Low ESL	LW reversed	p219
	LLA	Low ESL	8 terminals	p222
	LLM	Low ESL	10 terminals	p228
	LLR	Low ESL	LW reversed controlled ESR	p232
	NFM	Low ESL	3 terminals	p236
	GJ4	Anti-noise	Low distortion	WEB
	GJ8	Anti-noise	Low acoustic noise	WEB

On interposer board

	ZRA	Anti-noise		WEB
	ZRB	Anti-noise		WEB

Metal terminal type

	KRM	Anti-noise	Deflecting crack	Soldering crack		p239
	KR3	Anti-noise	Deflecting crack	Soldering crack	High effective capacitance & high ripple current	p243

Resin molding SMD type

	DK1	Safety standard		WEB
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Wire bonding mounting

Chip type

	GMA		Microchip	p249
	GMD			p256

Lead type

Solder mounting

	RDE	Anti-noise	Deflecting crack	Soldering crack		WEB
	DEH		High temperature low loss			WEB
	DEA		High temperature Class 1			WEB
	DEB		Class 2			WEB
	DEC					WEB
	DEF		For LCD backlight inverter circuit only			WEB
	DHR	Ultra-high voltage	Deflecting crack	Soldering crack		WEB
	DEJ	Japanese Safety Law	Based on the Electrical Appliance and Material Safety Law of Japan			WEB
	DE1	Safety standard	X1/Y1 Class certified product			WEB
	DE2	Safety standard	X1/Y2 Class certified product			WEB

Screw termination mounting

	DHS	Ultra-high voltage		WEB
	DHK	Ultra-high voltage	High voltage AC rated	WEB

Infotainment for automotive

SMD

Solder mounting

Chip type

	GRT			WEB
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Powertrain/Safety for automotive

SMD

Solder mounting

Chip type

	GCM			WEB		
	GC3	Anti-noise	High effective capacitance & high ripple current	WEB		
	GCJ	Fail safe	Deflecting crack	Soft termination	WEB	
	GGM	Water Repellent		WEB		
	GCQ	High Q		WEB		
	GCD	Fail safe	Deflecting crack	MLSC design	WEB	
	GCE	Fail safe	Deflecting crack	Soft termination MLSC design	WEB	
	GGD	Fail safe	Deflecting crack	Water Repellent	MLSC design	WEB
	NFM	Low ESL		3 terminals	WEB	

Metal terminal type

	KCM	Anti-noise	Deflecting crack	Soldering crack		WEB
	KC3	Anti-noise	Deflecting crack	Soldering crack	High effective capacitance & high ripple current	WEB
	KCA	Safety standard	Anti-noise	Deflecting crack	Soldering crack	WEB

Limited to Conductive Glue Mounting

Chip type

	GCB	Deflecting crack	Soldering crack	Ni plating + Pd plating termination conductive glue mounting	WEB
	GCG	Deflecting crack	Soldering crack	AgPd termination conductive glue mounting	WEB

Lead type

Solder mounting

	RCE	Anti-noise	Deflecting crack	Soldering crack		WEB
	RHE	Anti-noise	Deflecting crack	Soldering crack	150°C operation leaded	WEB
	RHS	Anti-noise	Deflecting crack	Soldering crack	200°C operation leaded	WEB
	DE6	Safety standard				WEB

Medical-grade products for implanted medical devices

SMD

Solder mounting

Chip type

	GCH			WEB
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● Part Numbering

Chip Multilayer Ceramic Capacitors for General



(Part Number)



① Product ID ② Series

Product ID	Code	Series
GA	2	Based on the Electrical Appliance and Material Safety Law of Japan Chip Multilayer Ceramic Capacitors for General Purpose
	3	Safety Standard Certified Chip Multilayer Ceramic Capacitors for General Purpose
GJ	M	High Q Chip Multilayer Ceramic Capacitors for General Purpose
GM	A	Wire Bonding Mount Multilayer Microchip Capacitors for General Purpose
	D	Wire Bonding/AuSn Soldering Mount Chip Multilayer Ceramic Capacitors for General Purpose
GQ	M	High Q and High Power Chip Multilayer Ceramic Capacitors for General Purpose
GR	3	High Effective Capacitance & High Ripple Current Chip Multilayer Ceramic Capacitors for General Purpose
	4	Chip Multilayer Ceramic Capacitors for Camera Flash Circuit only
	7	Chip Multilayer Ceramic Capacitors for Ethernet LAN and Primary-secondary Coupling of DC-DC Converters
	J	Soft Termination Chip Multilayer Ceramic Capacitors for General Purpose
KR	M	Chip Multilayer Ceramic Capacitors for General Purpose
	3	High Effective Capacitance & High Allowable Ripple Current Metal Terminal Type Multilayer Ceramic Capacitors for General Purpose
LL	M	Metal Terminal Type Multilayer Ceramic Capacitors for General Purpose
	A	8 Terminals Low ESL Chip Multilayer Ceramic Capacitors for General Purpose
	L	LW Reversed Low ESL Chip Multilayer Ceramic Capacitors for General Purpose
	M	10 Terminals Low ESL Chip Multilayer Ceramic Capacitors for General Purpose
	R	LW Reversed Controlled ESR Low ESL Chip Multilayer Ceramic Capacitors for General Purpose

③ Chip Dimensions (LxW)

Code	Dimensions (LxW)	EIA
02	0.4x0.2mm	01005
0D	0.38x0.38mm	015015
03	0.6x0.3mm	0201
05	0.5x0.5mm	0202
08	0.8x0.8mm	0303
1U	0.6x1.0mm	02404
15	1.0x0.5mm	0402
18	1.6x0.8mm	0603
21	2.0x1.25mm	0805
22	2.8x2.8mm	1111
31	3.2x1.6mm	1206
32	3.2x2.5mm	1210
42	4.5x2.0mm	1808
43	4.5x3.2mm	1812
52	5.7x2.8mm	2211
55	5.7x5.0mm	2220

Continued on the following page. ↗

(Part Number)

GR	M	18	8	B1	1H	102	K	A01	D
1	2	3	4	5	6	7	8	9	10

Continued from the preceding page. ↘

④ Height Dimension (T) (Except KR□)

Code	Dimension (T)
2	0.2mm
3	0.3mm
4	0.4mm
5	0.5mm
6	0.6mm
7	0.7mm
8	0.8mm
9	0.85mm
A	1.0mm
B	1.25mm
C	1.6mm
D	2.0mm
E	2.5mm
M	1.15mm
Q	1.5mm
X	Depends on individual standards.

④ Height Dimension (T) (KR□ Only)

Code	Dimension (T)
E	1.8mm
F	1.9mm
K	2.7mm
L	2.8mm
Q	3.7mm
T	4.8mm
W	6.4mm

⑤ Temperature Characteristics

Temperature Characteristic Codes		Temperature Characteristics				Operating Temperature Range	Capacitance Change Each Temperature (%)					
Code	Public STD Code	Reference Temperature	Temperature Range	Capacitance Change or Temperature Coefficient	-55°C		*6		-10°C			
					Max.		Min.	Max.	Min.	Max.	Min.	
1X	SL	JIS	20°C	20 to 85°C	+350 to -1000ppm/°C	-55 to 125°C	-	-	-	-	-	-
2C	CH	JIS	20°C	20 to 125°C	0±60ppm/°C	-55 to 125°C	0.82	-0.45	0.49	-0.27	0.33	-0.18
3C	CJ	JIS	20°C	20 to 125°C	0±120ppm/°C	-55 to 125°C	1.37	-0.9	0.82	-0.54	0.55	-0.36
3U	UJ	JIS	20°C	20 to 85°C	-750±120ppm/°C	-25 to 85°C	-	-	4.94	2.84	3.29	1.89
4C	CK	JIS	20°C	20 to 125°C	0±250ppm/°C	-55 to 125°C	2.56	-1.88	1.54	-1.13	1.02	-0.75
5C	C0G	EIA	25°C	25 to 125°C	0±30ppm/°C	-55 to 125°C	0.58	-0.24	0.4	-0.17	0.25	-0.11
5G	X8G	*2	25°C	25 to 150°C	0±30ppm/°C	-55 to 150°C	0.58	-0.24	0.4	-0.17	0.25	-0.11
7U	U2J	EIA	25°C	25 to 125°C *3	-750±120ppm/°C	-55 to 125°C	8.78	5.04	6.04	3.47	3.84	2.21
B1	B *1	JIS	20°C	-25 to 85°C	±10%	-25 to 85°C	-	-	-	-	-	-
B3	B	JIS	20°C	-25 to 85°C	±10%	-25 to 85°C	-	-	-	-	-	-
C7	X7S	EIA	25°C	-55 to 125°C	±22%	-55 to 125°C	-	-	-	-	-	-
C8	X6S	EIA	25°C	-55 to 105°C	±22%	-55 to 105°C	-	-	-	-	-	-
D7	X7T	EIA	25°C	-55 to 125°C	+22%, -33%	-55 to 125°C	-	-	-	-	-	-
D8	X6T	EIA	25°C	-55 to 105°C	+22%, -33%	-55 to 105°C	-	-	-	-	-	-
E7	X7U	EIA	25°C	-55 to 125°C	+22%, -56%	-55 to 125°C	-	-	-	-	-	-
R1	R *1	JIS	20°C	-55 to 125°C	±15%	-55 to 125°C	-	-	-	-	-	-
R6	X5R	EIA	25°C	-55 to 85°C	±15%	-55 to 85°C	-	-	-	-	-	-
R7	X7R	EIA	25°C	-55 to 125°C	±15%	-55 to 125°C	-	-	-	-	-	-
W0	X7T	EIA	25°C	-55 to 125°C	±10% *4	-55 to 125°C	-	-	-	-	-	-
					+22%, -33% *5		-	-	-	-	-	-

*1 Capacitance change is specified with 50% rated voltage applied.
 *2 Murata Temperature Characteristic Code.
 *3 Rated Voltage 100Vdc max: 25 to 85°C
 *4 Apply DC350V bias.
 *5 No DC bias.
 *6 -25°C (Reference Temperature 20°C) / -30°C (Reference Temperature 25°C)

Continued on the following page. ↗

(Part Number)

GR	M	18	8	B1	1H	102	K	A01	D
1	2	3	4	5	6	7	8	9	10

Continued from the preceding page. ↘

⑥ Rated Voltage

Code	Rated Voltage
OE	DC2.5V
OG	DC4V
OJ	DC6.3V
1A	DC10V
1C	DC16V
1E	DC25V
1H	DC50V
1J	DC63V
1K	DC80V
2A	DC100V
2D	DC200V
2E	DC250V
2W	DC450V
2H	DC500V
2J	DC630V
3A	DC1kV
3D	DC2kV
3F	DC3.15kV
BB	DC350V
E2	AC250V
GB	X2; AC250V (Safety Standard Certified Type GB)
GD	Y3; AC250V (Safety Standard Certified Type GD)
GF	Y2, X1/Y2; AC250V (Safety Standard Certified Type GF)
YA	DC35V

⑦ Capacitance

Expressed by three-digit alphanumerics. The unit is picofarad (pF). The first and second figures are significant digits, and the third figure expresses the number of zeros which follow the two numbers. If there is a decimal point, it is expressed by the capital letter "R." In this case, all figures are significant digits. If any alphabet, other than "R", is included, this indicates the specific part number is a non-standard part.

Ex.)

Code	Capacitance
R50	0.50pF
1R0	1.0pF
100	10pF
103	10000pF

⑧ Capacitance Tolerance

Code	Capacitance Tolerance
B	±0.1pF
C	±0.25pF
D	±0.5pF (Less than 10pF) ±0.5% (10pF and over)
F	±1%
G	±2%
J	±5%
K	±10%
M	±20%
W	±0.05pF

⑨ Individual Specification Code (Except LLR)

Expressed by three figures.

⑨ ESR (LLR Only)

Code	ESR
E01	100mΩ
E03	220mΩ
E05	470mΩ
E07	1000mΩ

⑩ Packaging

Code	Packaging
L	ø180mm Embossed Taping
D/E/W	ø180mm Paper Taping
K	ø330mm Embossed Taping
J/F	ø330mm Paper Taping
T	Bulk Tray

Please contact us if you find any part number not provided in this table.

High Q and High Power Chip Multilayer Ceramic Capacitors for General Purpose

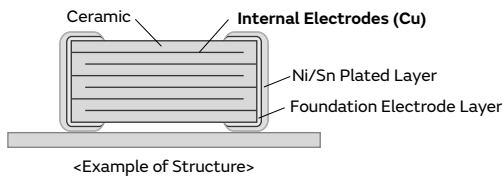
GQM Series  **High Q**  

High Frequency Capacitor Ideal for PA Design of Base Stations

Features

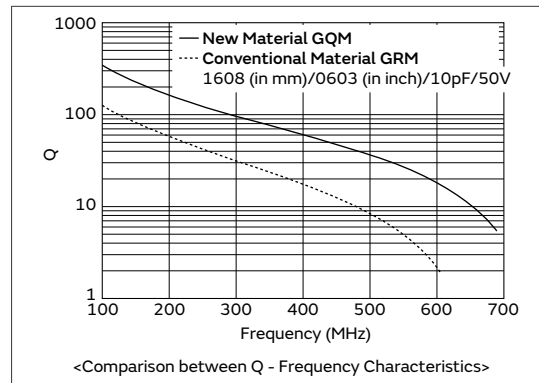
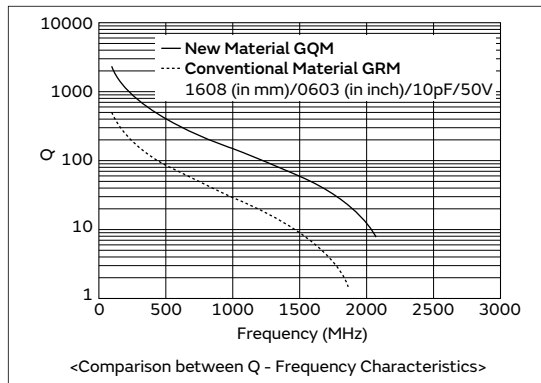
1 Mainly ideal for base stations of mobile communication devices and temperature compensation of related modules.

This product is ideal for temperature compensation of high frequency circuits, such as resonant circuits, tuning circuits, and impedance matching circuits where the operating characteristics of the device are greatly affected by the capacitance fluctuation.



2 High Q and low ESR in VHF, UHF and microwave frequency bands.

High Q and low ESR were achieved at a high frequency by adopting ceramic material as the dielectric material which enables an extremely low loss at high frequency, and base metal electrodes as the internal electrodes.



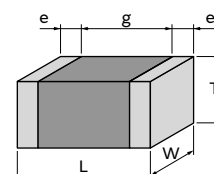
3 Can be used for tight tolerance.

In addition to standard tolerance, the allowable range of this product is also suitable for the following narrow tolerance.

Capacitance Range	Standard Capacitance Tolerance (Capacitance Tolerance Symbol)	Narrow Capacitance Tolerance (Capacitance Tolerance Symbol)
to 0.9pF	±0.1pF (B)	±0.05pF (W)
1.0 to 5.0pF	±0.25pF (C)	±0.05pF (W), ±0.1pF (B)
5.1 to 9.9pF	±0.5pF (D)	±0.05pF (W), ±0.1pF (B), ±0.25pF (C)
10pF to	±5% (J)	±2% (G)

Specifications

Size (mm)	1.0×0.5mm to 2.8×2.8mm
Rated Voltage	50Vdc to 500Vdc
Capacitance	0.10pF to 510pF
Main Applications	Measuring instruments, other ultra compact/thin devices



<Dimensions>

This catalog contains only a portion of the product lineup.
 Please refer to the capacitor search tool on the Murata Web site for details.

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 ⚠Caution /Notice

GQM Series Temperature Compensating Type Part Number List

1.0×0.5mm

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
0.55mm	200Vdc	COG	0.10pF	±0.1pF	GQM1555C2DR10BB01#	p172
				±0.25pF	GQM1555C2DR10CB01#	p172
			0.20pF	±0.1pF	GQM1555C2DR20BB01#	p172
				±0.25pF	GQM1555C2DR20CB01#	p172
			0.30pF	±0.1pF	GQM1555C2DR30BB01#	p172
				±0.25pF	GQM1555C2DR30CB01#	p172
			0.40pF	±0.1pF	GQM1555C2DR40BB01#	p172
				±0.25pF	GQM1555C2DR40CB01#	p172
			0.50pF	±0.1pF	GQM1555C2DR50BB01#	p172
				±0.25pF	GQM1555C2DR50CB01#	p172
			0.60pF	±0.1pF	GQM1555C2DR60BB01#	p172
				±0.25pF	GQM1555C2DR60CB01#	p172
			0.70pF	±0.1pF	GQM1555C2DR70BB01#	p172
				±0.25pF	GQM1555C2DR70CB01#	p172
			0.75pF	±0.1pF	GQM1555C2DR75BB01#	p172
				±0.25pF	GQM1555C2DR75CB01#	p172
			0.80pF	±0.1pF	GQM1555C2DR80BB01#	p172
				±0.25pF	GQM1555C2DR80CB01#	p172
			0.90pF	±0.1pF	GQM1555C2DR90BB01#	p172
				±0.25pF	GQM1555C2DR90CB01#	p172
			1.0pF	±0.1pF	GQM1555C2D1R0BB01#	p172
				±0.25pF	GQM1555C2D1R0CB01#	p172
			1.1pF	±0.1pF	GQM1555C2D1R1BB01#	p172
				±0.25pF	GQM1555C2D1R1CB01#	p172
			1.2pF	±0.1pF	GQM1555C2D1R2BB01#	p172
				±0.25pF	GQM1555C2D1R2CB01#	p172
			1.3pF	±0.1pF	GQM1555C2D1R3BB01#	p172
				±0.25pF	GQM1555C2D1R3CB01#	p172
			1.5pF	±0.1pF	GQM1555C2D1R5BB01#	p172
				±0.25pF	GQM1555C2D1R5CB01#	p172
			1.6pF	±0.1pF	GQM1555C2D1R6BB01#	p172
				±0.25pF	GQM1555C2D1R6CB01#	p172
			1.8pF	±0.1pF	GQM1555C2D1R8BB01#	p172
				±0.25pF	GQM1555C2D1R8CB01#	p172
			2.0pF	±0.1pF	GQM1555C2D2R0BB01#	p172
				±0.25pF	GQM1555C2D2R0CB01#	p172
			2.2pF	±0.1pF	GQM1555C2D2R2BB01#	p172
				±0.25pF	GQM1555C2D2R2CB01#	p172
			2.4pF	±0.1pF	GQM1555C2D2R4BB01#	p172
				±0.25pF	GQM1555C2D2R4CB01#	p172
			2.7pF	±0.1pF	GQM1555C2D2R7BB01#	p172
				±0.25pF	GQM1555C2D2R7CB01#	p172
			3.0pF	±0.1pF	GQM1555C2D3R0BB01#	p172
				±0.25pF	GQM1555C2D3R0CB01#	p172
			3.3pF	±0.1pF	GQM1555C2D3R3BB01#	p172
				±0.25pF	GQM1555C2D3R3CB01#	p172
			3.6pF	±0.1pF	GQM1555C2D3R6BB01#	p172
				±0.25pF	GQM1555C2D3R6CB01#	p172
3.9pF	±0.1pF	GQM1555C2D3R9BB01#	p172			
	±0.25pF	GQM1555C2D3R9CB01#	p172			
4.0pF	±0.1pF	GQM1555C2D4R0BB01#	p172			
	±0.25pF	GQM1555C2D4R0CB01#	p172			
4.3pF	±0.1pF	GQM1555C2D4R3BB01#	p172			
	±0.25pF	GQM1555C2D4R3CB01#	p172			

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
0.55mm	200Vdc	COG	4.7pF	±0.1pF	GQM1555C2D4R7BB01#	p172
				±0.25pF	GQM1555C2D4R7CB01#	p172
			5.0pF	±0.1pF	GQM1555C2D5R0BB01#	p172
				±0.25pF	GQM1555C2D5R0CB01#	p172
			5.1pF	±0.1pF	GQM1555C2D5R1BB01#	p172
				±0.25pF	GQM1555C2D5R1CB01#	p172
			5.6pF	±0.1pF	GQM1555C2D5R6BB01#	p172
				±0.25pF	GQM1555C2D5R6CB01#	p172
			6.0pF	±0.1pF	GQM1555C2D6R0BB01#	p172
				±0.25pF	GQM1555C2D6R0CB01#	p172
			6.2pF	±0.1pF	GQM1555C2D6R2BB01#	p172
				±0.25pF	GQM1555C2D6R2CB01#	p172
			6.8pF	±0.1pF	GQM1555C2D6R8BB01#	p172
				±0.25pF	GQM1555C2D6R8CB01#	p172
			7.0pF	±0.1pF	GQM1555C2D7R0BB01#	p172
				±0.25pF	GQM1555C2D7R0CB01#	p172
			7.5pF	±0.1pF	GQM1555C2D7R5BB01#	p172
				±0.25pF	GQM1555C2D7R5CB01#	p172
			8.0pF	±0.1pF	GQM1555C2D8R0BB01#	p172
				±0.25pF	GQM1555C2D8R0CB01#	p172
			8.2pF	±0.1pF	GQM1555C2D8R2BB01#	p172
				±0.25pF	GQM1555C2D8R2CB01#	p172
			9.0pF	±0.1pF	GQM1555C2D9R0BB01#	p172
				±0.25pF	GQM1555C2D9R0CB01#	p172
			9.1pF	±0.1pF	GQM1555C2D9R1BB01#	p172
				±0.25pF	GQM1555C2D9R1CB01#	p172
			10pF	±2%	GQM1555C2D100GB01#	p172
				±5%	GQM1555C2D100JB01#	p172
			11pF	±2%	GQM1555C2D110GB01#	p172
				±5%	GQM1555C2D110JB01#	p172
			12pF	±2%	GQM1555C2D120GB01#	p172
				±5%	GQM1555C2D120JB01#	p172
			13pF	±2%	GQM1555C2D130GB01#	p172
				±5%	GQM1555C2D130JB01#	p172
			15pF	±2%	GQM1555C2D150GB01#	p172
				±5%	GQM1555C2D150JB01#	p172
			16pF	±2%	GQM1555C2D160GB01#	p172
				±5%	GQM1555C2D160JB01#	p172
			18pF	±2%	GQM1555C2D180GB01#	p172
				±5%	GQM1555C2D180JB01#	p172
			20pF	±2%	GQM1555C2D200GB01#	p172
				±5%	GQM1555C2D200JB01#	p172
			22pF	±2%	GQM1555C2D220GB01#	p172
				±5%	GQM1555C2D220JB01#	p172
			24pF	±2%	GQM1555C2D240GB01#	p172
				±5%	GQM1555C2D240JB01#	p172
			27pF	±2%	GQM1555C2D270GB01#	p172
				±5%	GQM1555C2D270JB01#	p172
30pF	±2%	GQM1555C2D300GB01#	p172			
	±5%	GQM1555C2D300JB01#	p172			
33pF	±2%	GQM1555C2D330GB01#	p172			
	±5%	GQM1555C2D330JB01#	p172			
	100Vdc	COG	36pF	±2%	GQM1555C2A360GB01#	p172
				±5%	GQM1555C2A360JB01#	p172

*: Refers to the page of the "Specifications and Test Methods".

Part number # indicates the package specification code.

GQM Series Temperature Compensating Type Part Number List

(→ 1.0×0.5mm)

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
0.55mm	100Vdc	COG	39pF	±2%	GQM1555C2A390GB01#	p172
				±5%	GQM1555C2A390JB01#	p172
			43pF	±2%	GQM1555C2A430GB01#	p172
				±5%	GQM1555C2A430JB01#	p172
			47pF	±2%	GQM1555C2A470GB01#	p172
				±5%	GQM1555C2A470JB01#	p172

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
0.8mm	250Vdc	COG	6.0pF	±0.5pF	GQM1875C2E6R0DB12#	p178
				±0.25pF	GQM1875C2E6R2CB12#	p178
			6.2pF	±0.5pF	GQM1875C2E6R2DB12#	p178
				±0.25pF	GQM1875C2E6R8CB12#	p178
			6.8pF	±0.25pF	GQM1875C2E6R8DB12#	p178
				±0.5pF	GQM1875C2E7R0CB12#	p178
			7.0pF	±0.25pF	GQM1875C2E7R0DB12#	p178
				±0.5pF	GQM1875C2E7R5CB12#	p178
			7.5pF	±0.25pF	GQM1875C2E7R5DB12#	p178
				±0.5pF	GQM1875C2E8R0CB12#	p178
			8.0pF	±0.25pF	GQM1875C2E8R0DB12#	p178
				±0.5pF	GQM1875C2E8R2CB12#	p178
			8.2pF	±0.25pF	GQM1875C2E8R2DB12#	p178
				±0.5pF	GQM1875C2E9R0CB12#	p178
			9.0pF	±0.25pF	GQM1875C2E9R0DB12#	p178
				±0.5pF	GQM1875C2E9R1CB12#	p178
			9.1pF	±0.25pF	GQM1875C2E9R1DB12#	p178
				±0.5pF	GQM1875C2E100GB12#	p178
			10pF	±2%	GQM1875C2E100JB12#	p178
				±5%	GQM1875C2E110GB12#	p178
			11pF	±2%	GQM1875C2E110JB12#	p178
				±5%	GQM1875C2E120GB12#	p178
			12pF	±2%	GQM1875C2E120JB12#	p178
				±5%	GQM1875C2E130GB12#	p178
			13pF	±2%	GQM1875C2E130JB12#	p178
				±5%	GQM1875C2E150GB12#	p178
			15pF	±2%	GQM1875C2E150JB12#	p178
				±5%	GQM1875C2E160GB12#	p178
			16pF	±2%	GQM1875C2E160JB12#	p178
				±5%	GQM1875C2E180GB12#	p178
			18pF	±2%	GQM1875C2E180JB12#	p178
				±5%	GQM1875C2E200GB12#	p178
			20pF	±2%	GQM1875C2E200JB12#	p178
				±5%	GQM1875C2E220GB12#	p178
			22pF	±2%	GQM1875C2E220JB12#	p178
				±5%	GQM1875C2E240GB12#	p178
			24pF	±2%	GQM1875C2E240JB12#	p178
				±5%	GQM1875C2E270GB12#	p178
			27pF	±2%	GQM1875C2E270JB12#	p178
				±5%	GQM1875C2E300GB12#	p178
			30pF	±2%	GQM1875C2E300JB12#	p178
				±5%	GQM1875C2E330GB12#	p178
33pF	±2%	GQM1875C2E330JB12#	p178			
	±5%	GQM1875C2E360GB12#	p178			
36pF	±2%	GQM1875C2E360JB12#	p178			
	±5%	GQM1875C2E390GB12#	p178			
39pF	±2%	GQM1875C2E390JB12#	p178			
	±5%	GQM1875C2E430GB12#	p178			
43pF	±2%	GQM1875C2E430JB12#	p178			
	±5%	GQM1875C2E470GB12#	p178			
47pF	±2%	GQM1875C2E470JB12#	p178			
	±5%	GQM1875G2E1R0BB12#	p175			
X8G	1.0pF	±0.1pF	GQM1875G2E1R0CB12#	p175		
		±0.25pF	GQM1875G2E1R1BB12#	p175		
1.1pF	±0.1pF	GQM1875G2E1R1DB12#	p175			

1.6×0.8mm

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
0.8mm	250Vdc	COG	1.0pF	±0.1pF	GQM1875C2E1R0BB12#	p178
				±0.25pF	GQM1875C2E1R0CB12#	p178
			1.1pF	±0.1pF	GQM1875C2E1R1BB12#	p178
				±0.25pF	GQM1875C2E1R1CB12#	p178
			1.2pF	±0.1pF	GQM1875C2E1R2BB12#	p178
				±0.25pF	GQM1875C2E1R2CB12#	p178
			1.3pF	±0.1pF	GQM1875C2E1R3BB12#	p178
				±0.25pF	GQM1875C2E1R3CB12#	p178
			1.5pF	±0.1pF	GQM1875C2E1R5BB12#	p178
				±0.25pF	GQM1875C2E1R5CB12#	p178
			1.6pF	±0.1pF	GQM1875C2E1R6BB12#	p178
				±0.25pF	GQM1875C2E1R6CB12#	p178
			1.8pF	±0.1pF	GQM1875C2E1R8BB12#	p178
				±0.25pF	GQM1875C2E1R8CB12#	p178
			2.0pF	±0.1pF	GQM1875C2E2R0BB12#	p178
				±0.25pF	GQM1875C2E2R0CB12#	p178
			2.2pF	±0.1pF	GQM1875C2E2R2BB12#	p178
				±0.25pF	GQM1875C2E2R2CB12#	p178
			2.4pF	±0.1pF	GQM1875C2E2R4BB12#	p178
				±0.25pF	GQM1875C2E2R4CB12#	p178
			2.7pF	±0.1pF	GQM1875C2E2R7BB12#	p178
				±0.25pF	GQM1875C2E2R7CB12#	p178
			3.0pF	±0.1pF	GQM1875C2E3R0BB12#	p178
				±0.25pF	GQM1875C2E3R0CB12#	p178
			3.3pF	±0.1pF	GQM1875C2E3R3BB12#	p178
				±0.25pF	GQM1875C2E3R3CB12#	p178
			3.6pF	±0.1pF	GQM1875C2E3R6BB12#	p178
				±0.25pF	GQM1875C2E3R6CB12#	p178
			3.9pF	±0.1pF	GQM1875C2E3R9BB12#	p178
				±0.25pF	GQM1875C2E3R9CB12#	p178
			4.0pF	±0.1pF	GQM1875C2E4R0BB12#	p178
				±0.25pF	GQM1875C2E4R0CB12#	p178
			4.3pF	±0.1pF	GQM1875C2E4R3BB12#	p178
				±0.25pF	GQM1875C2E4R3CB12#	p178
			4.7pF	±0.1pF	GQM1875C2E4R7BB12#	p178
				±0.25pF	GQM1875C2E4R7CB12#	p178
			5.0pF	±0.1pF	GQM1875C2E5R0BB12#	p178
				±0.25pF	GQM1875C2E5R0CB12#	p178
			5.1pF	±0.25pF	GQM1875C2E5R1CB12#	p178
				±0.5pF	GQM1875C2E5R1DB12#	p178
			5.6pF	±0.25pF	GQM1875C2E5R6CB12#	p178
				±0.5pF	GQM1875C2E5R6DB12#	p178
			6.0pF	±0.25pF	GQM1875C2E6R0CB12#	p178

*: Refers to the page of the "Specifications and Test Methods".

Part number # indicates the package specification code.

GQM Series Temperature Compensating Type Part Number List

(→ 1.6×0.8mm)

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
0.8mm	250Vdc	X8G	1.1pF	±0.25pF	GQM1875G2E1R1CB12#	p175
				±0.1pF	GQM1875G2E1R2BB12#	p175
			1.2pF	±0.25pF	GQM1875G2E1R2CB12#	p175
				±0.1pF	GQM1875G2E1R3BB12#	p175
			1.3pF	±0.25pF	GQM1875G2E1R3CB12#	p175
				±0.1pF	GQM1875G2E1R5BB12#	p175
			1.5pF	±0.25pF	GQM1875G2E1R5CB12#	p175
				±0.1pF	GQM1875G2E1R6BB12#	p175
			1.6pF	±0.25pF	GQM1875G2E1R6CB12#	p175
				±0.1pF	GQM1875G2E1R8BB12#	p175
			1.8pF	±0.25pF	GQM1875G2E1R8CB12#	p175
				±0.1pF	GQM1875G2E2R0BB12#	p175
			2.0pF	±0.25pF	GQM1875G2E2R0CB12#	p175
				±0.1pF	GQM1875G2E2R2BB12#	p175
			2.2pF	±0.25pF	GQM1875G2E2R2CB12#	p175
				±0.1pF	GQM1875G2E2R4BB12#	p175
			2.4pF	±0.25pF	GQM1875G2E2R4CB12#	p175
				±0.1pF	GQM1875G2E2R7BB12#	p175
			2.7pF	±0.25pF	GQM1875G2E2R7CB12#	p175
				±0.1pF	GQM1875G2E3R0BB12#	p175
			3.0pF	±0.25pF	GQM1875G2E3R0CB12#	p175
				±0.1pF	GQM1875G2E3R3BB12#	p175
			3.3pF	±0.25pF	GQM1875G2E3R3CB12#	p175
				±0.1pF	GQM1875G2E3R6BB12#	p175
			3.6pF	±0.25pF	GQM1875G2E3R6CB12#	p175
				±0.1pF	GQM1875G2E3R9BB12#	p175
			3.9pF	±0.25pF	GQM1875G2E3R9CB12#	p175
				±0.1pF	GQM1875G2E4R0BB12#	p175
			4.0pF	±0.25pF	GQM1875G2E4R0CB12#	p175
				±0.1pF	GQM1875G2E4R3BB12#	p175
			4.3pF	±0.25pF	GQM1875G2E4R3CB12#	p175
				±0.1pF	GQM1875G2E4R7BB12#	p175
			4.7pF	±0.25pF	GQM1875G2E4R7CB12#	p175
				±0.1pF	GQM1875G2E5R0BB12#	p175
			5.0pF	±0.25pF	GQM1875G2E5R0CB12#	p175
				±0.1pF	GQM1875G2E5R1CB12#	p175
			5.1pF	±0.5pF	GQM1875G2E5R1DB12#	p175
				±0.25pF	GQM1875G2E5R6CB12#	p175
			5.6pF	±0.5pF	GQM1875G2E5R6DB12#	p175
				±0.25pF	GQM1875G2E6R0CB12#	p175
			6.0pF	±0.5pF	GQM1875G2E6R0DB12#	p175
				±0.25pF	GQM1875G2E6R2CB12#	p175
			6.2pF	±0.5pF	GQM1875G2E6R2DB12#	p175
				±0.25pF	GQM1875G2E6R8CB12#	p175
			6.8pF	±0.5pF	GQM1875G2E6R8DB12#	p175
				±0.25pF	GQM1875G2E7R0CB12#	p175
			7.0pF	±0.5pF	GQM1875G2E7R0DB12#	p175
				±0.25pF	GQM1875G2E7R5CB12#	p175
			7.5pF	±0.5pF	GQM1875G2E7R5DB12#	p175
				±0.25pF	GQM1875G2E8R0CB12#	p175
			8.0pF	±0.5pF	GQM1875G2E8R0DB12#	p175
				±0.25pF	GQM1875G2E8R2CB12#	p175
			8.2pF	±0.5pF	GQM1875G2E8R2DB12#	p175
				±0.25pF	GQM1875G2E9R0CB12#	p175

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
0.8mm	250Vdc	X8G	9.0pF	±0.5pF	GQM1875G2E9R0DB12#	p175
				±0.25pF	GQM1875G2E9R1CB12#	p175
			9.1pF	±0.5pF	GQM1875G2E9R1DB12#	p175
				±2%	GQM1875G2E100GB12#	p175
			10pF	±5%	GQM1875G2E100JB12#	p175
				±2%	GQM1875G2E110GB12#	p175
			11pF	±5%	GQM1875G2E110JB12#	p175
				±2%	GQM1875G2E120GB12#	p175
			12pF	±5%	GQM1875G2E120JB12#	p175
				±2%	GQM1875G2E130GB12#	p175
			13pF	±5%	GQM1875G2E130JB12#	p175
				±2%	GQM1875G2E150GB12#	p175
			15pF	±5%	GQM1875G2E150JB12#	p175
				±2%	GQM1875G2E160GB12#	p175
			16pF	±5%	GQM1875G2E160JB12#	p175
				±2%	GQM1875G2E180GB12#	p175
			18pF	±5%	GQM1875G2E180JB12#	p175
				±2%	GQM1875G2E200GB12#	p175
			20pF	±5%	GQM1875G2E200JB12#	p175
				±2%	GQM1875G2E220GB12#	p175
			22pF	±5%	GQM1875G2E220JB12#	p175
				±2%	GQM1875G2E240GB12#	p175
			24pF	±5%	GQM1875G2E240JB12#	p175
				±2%	GQM1875G2E270GB12#	p175
27pF	±5%	GQM1875G2E270JB12#	p175			
	±2%	GQM1875G2E300GB12#	p175			
30pF	±5%	GQM1875G2E300JB12#	p175			

2.0×1.25mm

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
1.0mm	500Vdc	X8G	1.0pF	±0.1pF	GQM2195G2H1R0BB12#	p175
				±0.25pF	GQM2195G2H1R0CB12#	p175
			1.1pF	±0.1pF	GQM2195G2H1R1BB12#	p175
				±0.25pF	GQM2195G2H1R1CB12#	p175
			1.2pF	±0.1pF	GQM2195G2H1R2BB12#	p175
				±0.25pF	GQM2195G2H1R2CB12#	p175
			1.3pF	±0.1pF	GQM2195G2H1R3BB12#	p175
				±0.25pF	GQM2195G2H1R3CB12#	p175
			1.5pF	±0.1pF	GQM2195G2H1R5BB12#	p175
				±0.25pF	GQM2195G2H1R5CB12#	p175
			1.6pF	±0.1pF	GQM2195G2H1R6BB12#	p175
				±0.25pF	GQM2195G2H1R6CB12#	p175
			1.8pF	±0.1pF	GQM2195G2H1R8BB12#	p175
				±0.25pF	GQM2195G2H1R8CB12#	p175
			2.0pF	±0.1pF	GQM2195G2H2R0BB12#	p175
				±0.25pF	GQM2195G2H2R0CB12#	p175
			2.2pF	±0.1pF	GQM2195G2H2R2BB12#	p175
				±0.25pF	GQM2195G2H2R2CB12#	p175
			2.4pF	±0.1pF	GQM2195G2H2R4BB12#	p175
				±0.25pF	GQM2195G2H2R4CB12#	p175
			2.7pF	±0.1pF	GQM2195G2H2R7BB12#	p175
				±0.25pF	GQM2195G2H2R7CB12#	p175

*: Refers to the page of the "Specifications and Test Methods".

Part number # indicates the package specification code.

GRM
 GR3
 GRJ
 GRU
 GR4
 GR7
 GJM
 GQM
 GA2
 GA3
 GB
 GA3
 GD
 GA3
 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 ⚠Caution / Notice

GQM Series Temperature Compensating Type Part Number List

(→ 2.0×1.25mm)

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
1.0mm	500Vdc	X8G	3.0pF	±0.1pF	GQM2195G2H3R0BB12#	p175
				±0.25pF	GQM2195G2H3R0CB12#	p175
			3.3pF	±0.1pF	GQM2195G2H3R3BB12#	p175
				±0.25pF	GQM2195G2H3R3CB12#	p175
			3.6pF	±0.1pF	GQM2195G2H3R6BB12#	p175
				±0.25pF	GQM2195G2H3R6CB12#	p175
			3.9pF	±0.1pF	GQM2195G2H3R9BB12#	p175
				±0.25pF	GQM2195G2H3R9CB12#	p175
			4.0pF	±0.1pF	GQM2195G2H4R0BB12#	p175
				±0.25pF	GQM2195G2H4R0CB12#	p175
			4.3pF	±0.1pF	GQM2195G2H4R3BB12#	p175
				±0.25pF	GQM2195G2H4R3CB12#	p175
			4.7pF	±0.1pF	GQM2195G2H4R7BB12#	p175
				±0.25pF	GQM2195G2H4R7CB12#	p175
			5.0pF	±0.1pF	GQM2195G2H5R0BB12#	p175
				±0.25pF	GQM2195G2H5R0CB12#	p175
			5.1pF	±0.25pF	GQM2195G2H5R1CB12#	p175
				±0.5pF	GQM2195G2H5R1DB12#	p175
			5.6pF	±0.25pF	GQM2195G2H5R6CB12#	p175
				±0.5pF	GQM2195G2H5R6DB12#	p175
			6.0pF	±0.25pF	GQM2195G2H6R0CB12#	p175
				±0.5pF	GQM2195G2H6R0DB12#	p175
			6.2pF	±0.25pF	GQM2195G2H6R2CB12#	p175
				±0.5pF	GQM2195G2H6R2DB12#	p175
			6.8pF	±0.25pF	GQM2195G2H6R8CB12#	p175
				±0.5pF	GQM2195G2H6R8DB12#	p175
			7.0pF	±0.25pF	GQM2195G2H7R0CB12#	p175
				±0.5pF	GQM2195G2H7R0DB12#	p175
			7.5pF	±0.25pF	GQM2195G2H7R5CB12#	p175
				±0.5pF	GQM2195G2H7R5DB12#	p175
			8.0pF	±0.25pF	GQM2195G2H8R0CB12#	p175
				±0.5pF	GQM2195G2H8R0DB12#	p175
			8.2pF	±0.25pF	GQM2195G2H8R2CB12#	p175
				±0.5pF	GQM2195G2H8R2DB12#	p175
			9.0pF	±0.25pF	GQM2195G2H9R0CB12#	p175
				±0.5pF	GQM2195G2H9R0DB12#	p175
			9.1pF	±0.25pF	GQM2195G2H9R1CB12#	p175
				±0.5pF	GQM2195G2H9R1DB12#	p175
			10pF	±2%	GQM2195G2H100GB12#	p175
				±5%	GQM2195G2H100JB12#	p175
			11pF	±2%	GQM2195G2H110GB12#	p175
				±5%	GQM2195G2H110JB12#	p175
			12pF	±2%	GQM2195G2H120GB12#	p175
				±5%	GQM2195G2H120JB12#	p175
			13pF	±2%	GQM2195G2H130GB12#	p175
				±5%	GQM2195G2H130JB12#	p175
			15pF	±2%	GQM2195G2H150GB12#	p175
				±5%	GQM2195G2H150JB12#	p175
16pF	±2%	GQM2195G2H160GB12#	p175			
	±5%	GQM2195G2H160JB12#	p175			
18pF	±2%	GQM2195G2H180GB12#	p175			
	±5%	GQM2195G2H180JB12#	p175			
20pF	±2%	GQM2195G2H200GB12#	p175			
	±5%	GQM2195G2H200JB12#	p175			

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*		
1.0mm	500Vdc	X8G	22pF	±2%	GQM2195G2H220GB12#	p175		
				±5%	GQM2195G2H220JB12#	p175		
			250Vdc	COG	1.0pF	±0.1pF	GQM2195C2E1R0BB12#	p178
						±0.25pF	GQM2195C2E1R0CB12#	p178
			1.1pF	±0.1pF	GQM2195C2E1R1BB12#	p178		
				±0.25pF	GQM2195C2E1R1CB12#	p178		
			1.2pF	±0.1pF	GQM2195C2E1R2BB12#	p178		
				±0.25pF	GQM2195C2E1R2CB12#	p178		
			1.3pF	±0.1pF	GQM2195C2E1R3BB12#	p178		
				±0.25pF	GQM2195C2E1R3CB12#	p178		
			1.5pF	±0.1pF	GQM2195C2E1R5BB12#	p178		
				±0.25pF	GQM2195C2E1R5CB12#	p178		
			1.6pF	±0.1pF	GQM2195C2E1R6BB12#	p178		
				±0.25pF	GQM2195C2E1R6CB12#	p178		
			1.8pF	±0.1pF	GQM2195C2E1R8BB12#	p178		
				±0.25pF	GQM2195C2E1R8CB12#	p178		
			2.0pF	±0.1pF	GQM2195C2E2R0BB12#	p178		
				±0.25pF	GQM2195C2E2R0CB12#	p178		
			2.2pF	±0.1pF	GQM2195C2E2R2BB12#	p178		
				±0.25pF	GQM2195C2E2R2CB12#	p178		
			2.4pF	±0.1pF	GQM2195C2E2R4BB12#	p178		
				±0.25pF	GQM2195C2E2R4CB12#	p178		
			2.7pF	±0.1pF	GQM2195C2E2R7BB12#	p178		
				±0.25pF	GQM2195C2E2R7CB12#	p178		
	3.0pF	±0.1pF	GQM2195C2E3R0BB12#	p178				
		±0.25pF	GQM2195C2E3R0CB12#	p178				
	3.3pF	±0.1pF	GQM2195C2E3R3BB12#	p178				
		±0.25pF	GQM2195C2E3R3CB12#	p178				
	3.6pF	±0.1pF	GQM2195C2E3R6BB12#	p178				
		±0.25pF	GQM2195C2E3R6CB12#	p178				
	3.9pF	±0.1pF	GQM2195C2E3R9BB12#	p178				
		±0.25pF	GQM2195C2E3R9CB12#	p178				
	4.0pF	±0.1pF	GQM2195C2E4R0BB12#	p178				
		±0.25pF	GQM2195C2E4R0CB12#	p178				
	4.3pF	±0.1pF	GQM2195C2E4R3BB12#	p178				
		±0.25pF	GQM2195C2E4R3CB12#	p178				
	4.7pF	±0.1pF	GQM2195C2E4R7BB12#	p178				
		±0.25pF	GQM2195C2E4R7CB12#	p178				
	5.0pF	±0.1pF	GQM2195C2E5R0BB12#	p178				
		±0.25pF	GQM2195C2E5R0CB12#	p178				
	5.1pF	±0.25pF	GQM2195C2E5R1CB12#	p178				
		±0.5pF	GQM2195C2E5R1DB12#	p178				
	5.6pF	±0.25pF	GQM2195C2E5R6CB12#	p178				
		±0.5pF	GQM2195C2E5R6DB12#	p178				
	6.0pF	±0.25pF	GQM2195C2E6R0CB12#	p178				
		±0.5pF	GQM2195C2E6R0DB12#	p178				
	6.2pF	±0.25pF	GQM2195C2E6R2CB12#	p178				
		±0.5pF	GQM2195C2E6R2DB12#	p178				
6.8pF	±0.25pF	GQM2195C2E6R8CB12#	p178					
	±0.5pF	GQM2195C2E6R8DB12#	p178					
7.0pF	±0.25pF	GQM2195C2E7R0CB12#	p178					
	±0.5pF	GQM2195C2E7R0DB12#	p178					
7.5pF	±0.25pF	GQM2195C2E7R5CB12#	p178					
	±0.5pF	GQM2195C2E7R5DB12#	p178					

*: Refers to the page of the "Specifications and Test Methods".

Part number # indicates the package specification code.

GQM Series Temperature Compensating Type Part Number List

(→ 2.0×1.25mm)

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
1.0mm	250Vdc	COG	8.0pF	±0.25pF	GQM2195C2E8R0CB12#	p178
				±0.5pF	GQM2195C2E8R0DB12#	p178
			8.2pF	±0.25pF	GQM2195C2E8R2CB12#	p178
				±0.5pF	GQM2195C2E8R2DB12#	p178
			9.0pF	±0.25pF	GQM2195C2E9R0CB12#	p178
				±0.5pF	GQM2195C2E9R0DB12#	p178
			9.1pF	±0.25pF	GQM2195C2E9R1CB12#	p178
				±0.5pF	GQM2195C2E9R1DB12#	p178
			10pF	±2%	GQM2195C2E100GB12#	p178
				±5%	GQM2195C2E100JB12#	p178
			11pF	±2%	GQM2195C2E110GB12#	p178
				±5%	GQM2195C2E110JB12#	p178
			12pF	±2%	GQM2195C2E120GB12#	p178
				±5%	GQM2195C2E120JB12#	p178
			13pF	±2%	GQM2195C2E130GB12#	p178
				±5%	GQM2195C2E130JB12#	p178
			15pF	±2%	GQM2195C2E150GB12#	p178
				±5%	GQM2195C2E150JB12#	p178
			16pF	±2%	GQM2195C2E160GB12#	p178
				±5%	GQM2195C2E160JB12#	p178
			18pF	±2%	GQM2195C2E180GB12#	p178
				±5%	GQM2195C2E180JB12#	p178
			20pF	±2%	GQM2195C2E200GB12#	p178
				±5%	GQM2195C2E200JB12#	p178
			22pF	±2%	GQM2195C2E220GB12#	p178
				±5%	GQM2195C2E220JB12#	p178
			24pF	±2%	GQM2195C2E240GB12#	p178
				±5%	GQM2195C2E240JB12#	p178
			27pF	±2%	GQM2195C2E270GB12#	p178
				±5%	GQM2195C2E270JB12#	p178
			30pF	±2%	GQM2195C2E300GB12#	p178
				±5%	GQM2195C2E300JB12#	p178
			33pF	±2%	GQM2195C2E330GB12#	p178
				±5%	GQM2195C2E330JB12#	p178
			36pF	±2%	GQM2195C2E360GB12#	p178
				±5%	GQM2195C2E360JB12#	p178
			39pF	±2%	GQM2195C2E390GB12#	p178
				±5%	GQM2195C2E390JB12#	p178
			43pF	±2%	GQM2195C2E430GB12#	p178
				±5%	GQM2195C2E430JB12#	p178
			47pF	±2%	GQM2195C2E470GB12#	p178
				±5%	GQM2195C2E470JB12#	p178
			51pF	±2%	GQM2195C2E510GB12#	p178
				±5%	GQM2195C2E510JB12#	p178
			56pF	±2%	GQM2195C2E560GB12#	p178
				±5%	GQM2195C2E560JB12#	p178
			62pF	±2%	GQM2195C2E620GB12#	p178
				±5%	GQM2195C2E620JB12#	p178
			68pF	±2%	GQM2195C2E680GB12#	p178
				±5%	GQM2195C2E680JB12#	p178
			75pF	±2%	GQM2195C2E750GB12#	p178
				±5%	GQM2195C2E750JB12#	p178
82pF	±2%	GQM2195C2E820GB12#	p178			
	±5%	GQM2195C2E820JB12#	p178			

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*	
1.0mm	250Vdc	COG	91pF	±2%	GQM2195C2E910GB12#	p178	
				±5%	GQM2195C2E910JB12#	p178	
			100pF	±2%	GQM2195C2E101GB12#	p178	
				±5%	GQM2195C2E101JB12#	p178	
			X8G	1.0pF	±0.1pF	GQM2195G2E1R0BB12#	p175
					±0.25pF	GQM2195G2E1R0CB12#	p175
				1.1pF	±0.1pF	GQM2195G2E1R1BB12#	p175
					±0.25pF	GQM2195G2E1R1CB12#	p175
				1.2pF	±0.1pF	GQM2195G2E1R2BB12#	p175
					±0.25pF	GQM2195G2E1R2CB12#	p175
				1.3pF	±0.1pF	GQM2195G2E1R3BB12#	p175
					±0.25pF	GQM2195G2E1R3CB12#	p175
		1.5pF		±0.1pF	GQM2195G2E1R5BB12#	p175	
				±0.25pF	GQM2195G2E1R5CB12#	p175	
		1.6pF		±0.1pF	GQM2195G2E1R6BB12#	p175	
				±0.25pF	GQM2195G2E1R6CB12#	p175	
		1.8pF		±0.1pF	GQM2195G2E1R8BB12#	p175	
				±0.25pF	GQM2195G2E1R8CB12#	p175	
		2.0pF		±0.1pF	GQM2195G2E2R0BB12#	p175	
				±0.25pF	GQM2195G2E2R0CB12#	p175	
		2.2pF		±0.1pF	GQM2195G2E2R2BB12#	p175	
				±0.25pF	GQM2195G2E2R2CB12#	p175	
		2.4pF		±0.1pF	GQM2195G2E2R4BB12#	p175	
				±0.25pF	GQM2195G2E2R4CB12#	p175	
		2.7pF		±0.1pF	GQM2195G2E2R7BB12#	p175	
				±0.25pF	GQM2195G2E2R7CB12#	p175	
		3.0pF		±0.1pF	GQM2195G2E3R0BB12#	p175	
				±0.25pF	GQM2195G2E3R0CB12#	p175	
		3.3pF		±0.1pF	GQM2195G2E3R3BB12#	p175	
				±0.25pF	GQM2195G2E3R3CB12#	p175	
		3.6pF		±0.1pF	GQM2195G2E3R6BB12#	p175	
				±0.25pF	GQM2195G2E3R6CB12#	p175	
		3.9pF		±0.1pF	GQM2195G2E3R9BB12#	p175	
				±0.25pF	GQM2195G2E3R9CB12#	p175	
		4.0pF		±0.1pF	GQM2195G2E4R0BB12#	p175	
				±0.25pF	GQM2195G2E4R0CB12#	p175	
		4.3pF		±0.1pF	GQM2195G2E4R3BB12#	p175	
				±0.25pF	GQM2195G2E4R3CB12#	p175	
		4.7pF		±0.1pF	GQM2195G2E4R7BB12#	p175	
				±0.25pF	GQM2195G2E4R7CB12#	p175	
		5.0pF		±0.1pF	GQM2195G2E5R0BB12#	p175	
				±0.25pF	GQM2195G2E5R0CB12#	p175	
		5.1pF		±0.25pF	GQM2195G2E5R1CB12#	p175	
				±0.5pF	GQM2195G2E5R1DB12#	p175	
		5.6pF	±0.25pF	GQM2195G2E5R6CB12#	p175		
			±0.5pF	GQM2195G2E5R6DB12#	p175		
		6.0pF	±0.25pF	GQM2195G2E6R0CB12#	p175		
			±0.5pF	GQM2195G2E6R0DB12#	p175		
		6.2pF	±0.25pF	GQM2195G2E6R2CB12#	p175		
			±0.5pF	GQM2195G2E6R2DB12#	p175		
		6.8pF	±0.25pF	GQM2195G2E6R8CB12#	p175		
			±0.5pF	GQM2195G2E6R8DB12#	p175		
7.0pF	±0.25pF	GQM2195G2E7R0CB12#	p175				
	±0.5pF	GQM2195G2E7R0DB12#	p175				

*: Refers to the page of the "Specifications and Test Methods".

Part number # indicates the package specification code.

GQM Series Temperature Compensating Type Part Number List

(→ 2.0×1.25mm)

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
1.0mm	250Vdc	X8G	7.5pF	±0.25pF	GQM2195G2E7R5CB12#	p175
				±0.5pF	GQM2195G2E7R5DB12#	p175
			8.0pF	±0.25pF	GQM2195G2E8R0CB12#	p175
				±0.5pF	GQM2195G2E8R0DB12#	p175
			8.2pF	±0.25pF	GQM2195G2E8R2CB12#	p175
				±0.5pF	GQM2195G2E8R2DB12#	p175
			9.0pF	±0.25pF	GQM2195G2E9R0CB12#	p175
				±0.5pF	GQM2195G2E9R0DB12#	p175
			9.1pF	±0.25pF	GQM2195G2E9R1CB12#	p175
				±0.5pF	GQM2195G2E9R1DB12#	p175
			10pF	±2%	GQM2195G2E100GB12#	p175
				±5%	GQM2195G2E100JB12#	p175
			11pF	±2%	GQM2195G2E110GB12#	p175
				±5%	GQM2195G2E110JB12#	p175
			12pF	±2%	GQM2195G2E120GB12#	p175
				±5%	GQM2195G2E120JB12#	p175
			13pF	±2%	GQM2195G2E130GB12#	p175
				±5%	GQM2195G2E130JB12#	p175
			15pF	±2%	GQM2195G2E150GB12#	p175
				±5%	GQM2195G2E150JB12#	p175
			16pF	±2%	GQM2195G2E160GB12#	p175
				±5%	GQM2195G2E160JB12#	p175
			18pF	±2%	GQM2195G2E180GB12#	p175
				±5%	GQM2195G2E180JB12#	p175
			20pF	±2%	GQM2195G2E200GB12#	p175
				±5%	GQM2195G2E200JB12#	p175
			22pF	±2%	GQM2195G2E220GB12#	p175
				±5%	GQM2195G2E220JB12#	p175
			24pF	±2%	GQM2195G2E240GB12#	p175
				±5%	GQM2195G2E240JB12#	p175
			27pF	±2%	GQM2195G2E270GB12#	p175
				±5%	GQM2195G2E270JB12#	p175
			30pF	±2%	GQM2195G2E300GB12#	p175
				±5%	GQM2195G2E300JB12#	p175
			33pF	±2%	GQM2195G2E330GB12#	p175
				±5%	GQM2195G2E330JB12#	p175
			36pF	±2%	GQM2195G2E360GB12#	p175
				±5%	GQM2195G2E360JB12#	p175
			39pF	±2%	GQM2195G2E390GB12#	p175
				±5%	GQM2195G2E390JB12#	p175
			43pF	±2%	GQM2195G2E430GB12#	p175
				±5%	GQM2195G2E430JB12#	p175
			47pF	±2%	GQM2195G2E470GB12#	p175
				±5%	GQM2195G2E470JB12#	p175
			51pF	±2%	GQM2195G2E510GB12#	p175
				±5%	GQM2195G2E510JB12#	p175
			56pF	±2%	GQM2195G2E560GB12#	p175
				±5%	GQM2195G2E560JB12#	p175
			62pF	±2%	GQM2195G2E620GB12#	p175
				±5%	GQM2195G2E620JB12#	p175
			68pF	±2%	GQM2195G2E680GB12#	p175
				±5%	GQM2195G2E680JB12#	p175
			75pF	±2%	GQM2195G2E750GB12#	p175
				±5%	GQM2195G2E750JB12#	p175

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
1.0mm	250Vdc	X8G	82pF	±2%	GQM2195G2E820GB12#	p175
				±5%	GQM2195G2E820JB12#	p175

2.8×2.8mm

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
1.35mm	500Vdc	COG	1.0pF	±0.1pF	GQM22M5C2H1R0BB01#	p181
				±0.25pF	GQM22M5C2H1R0CB01#	p181
			1.1pF	±0.1pF	GQM22M5C2H1R1BB01#	p181
				±0.25pF	GQM22M5C2H1R1CB01#	p181
			1.2pF	±0.1pF	GQM22M5C2H1R2BB01#	p181
				±0.25pF	GQM22M5C2H1R2CB01#	p181
			1.3pF	±0.1pF	GQM22M5C2H1R3BB01#	p181
				±0.25pF	GQM22M5C2H1R3CB01#	p181
			1.5pF	±0.1pF	GQM22M5C2H1R5BB01#	p181
				±0.25pF	GQM22M5C2H1R5CB01#	p181
			1.6pF	±0.1pF	GQM22M5C2H1R6BB01#	p181
				±0.25pF	GQM22M5C2H1R6CB01#	p181
			1.8pF	±0.1pF	GQM22M5C2H1R8BB01#	p181
				±0.25pF	GQM22M5C2H1R8CB01#	p181
			2.0pF	±0.1pF	GQM22M5C2H2R0BB01#	p181
				±0.25pF	GQM22M5C2H2R0CB01#	p181
			2.2pF	±0.1pF	GQM22M5C2H2R2BB01#	p181
				±0.25pF	GQM22M5C2H2R2CB01#	p181
			2.4pF	±0.1pF	GQM22M5C2H2R4BB01#	p181
				±0.25pF	GQM22M5C2H2R4CB01#	p181
			2.7pF	±0.1pF	GQM22M5C2H2R7BB01#	p181
				±0.25pF	GQM22M5C2H2R7CB01#	p181
			3.0pF	±0.1pF	GQM22M5C2H3R0BB01#	p181
				±0.25pF	GQM22M5C2H3R0CB01#	p181
			3.3pF	±0.1pF	GQM22M5C2H3R3BB01#	p181
				±0.25pF	GQM22M5C2H3R3CB01#	p181
			3.6pF	±0.1pF	GQM22M5C2H3R6BB01#	p181
				±0.25pF	GQM22M5C2H3R6CB01#	p181
			3.9pF	±0.1pF	GQM22M5C2H3R9BB01#	p181
				±0.25pF	GQM22M5C2H3R9CB01#	p181
			4.0pF	±0.1pF	GQM22M5C2H4R0BB01#	p181
				±0.25pF	GQM22M5C2H4R0CB01#	p181
			4.3pF	±0.1pF	GQM22M5C2H4R3BB01#	p181
				±0.25pF	GQM22M5C2H4R3CB01#	p181
			4.7pF	±0.1pF	GQM22M5C2H4R7BB01#	p181
				±0.25pF	GQM22M5C2H4R7CB01#	p181
			5.0pF	±0.1pF	GQM22M5C2H5R0BB01#	p181
				±0.25pF	GQM22M5C2H5R0CB01#	p181
			5.1pF	±0.25pF	GQM22M5C2H5R1CB01#	p181
				±0.5pF	GQM22M5C2H5R1DB01#	p181
			5.6pF	±0.25pF	GQM22M5C2H5R6CB01#	p181
				±0.5pF	GQM22M5C2H5R6DB01#	p181
6.0pF	±0.25pF	GQM22M5C2H6R0CB01#	p181			
	±0.5pF	GQM22M5C2H6R0DB01#	p181			
6.2pF	±0.25pF	GQM22M5C2H6R2CB01#	p181			
	±0.5pF	GQM22M5C2H6R2DB01#	p181			
6.8pF	±0.25pF	GQM22M5C2H6R8CB01#	p181			

*: Refers to the page of the "Specifications and Test Methods".

Part number # indicates the package specification code.

GQM Series Temperature Compensating Type Part Number List

(→ 2.8×2.8mm)

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
1.35mm	500Vdc	COG	6.8pF	±0.5pF	GQM22M5C2H6R8DB01#	p181
				±0.25pF	GQM22M5C2H7R0CB01#	p181
			7.0pF	±0.5pF	GQM22M5C2H7R0DB01#	p181
				±0.25pF	GQM22M5C2H7R5CB01#	p181
			7.5pF	±0.25pF	GQM22M5C2H7R5DB01#	p181
				±0.5pF	GQM22M5C2H8R0CB01#	p181
			8.0pF	±0.25pF	GQM22M5C2H8R0DB01#	p181
				±0.5pF	GQM22M5C2H8R2CB01#	p181
			8.2pF	±0.25pF	GQM22M5C2H8R2DB01#	p181
				±0.5pF	GQM22M5C2H9R0CB01#	p181
			9.0pF	±0.25pF	GQM22M5C2H9R0DB01#	p181
				±0.5pF	GQM22M5C2H9R1CB01#	p181
			9.1pF	±0.25pF	GQM22M5C2H9R1DB01#	p181
				±0.5pF	GQM22M5C2H100GB01#	p181
			10pF	±2%	GQM22M5C2H100JB01#	p181
				±5%	GQM22M5C2H110GB01#	p181
			11pF	±2%	GQM22M5C2H110JB01#	p181
				±5%	GQM22M5C2H120GB01#	p181
			12pF	±2%	GQM22M5C2H120JB01#	p181
				±5%	GQM22M5C2H130GB01#	p181
			13pF	±2%	GQM22M5C2H130JB01#	p181
				±5%	GQM22M5C2H150GB01#	p181
			15pF	±2%	GQM22M5C2H150JB01#	p181
				±5%	GQM22M5C2H160GB01#	p181
			16pF	±2%	GQM22M5C2H160JB01#	p181
				±5%	GQM22M5C2H180GB01#	p181
			18pF	±2%	GQM22M5C2H180JB01#	p181
				±5%	GQM22M5C2H200GB01#	p181
			20pF	±2%	GQM22M5C2H200JB01#	p181
				±5%	GQM22M5C2H220GB01#	p181
			22pF	±2%	GQM22M5C2H220JB01#	p181
				±5%	GQM22M5C2H240GB01#	p181
			24pF	±2%	GQM22M5C2H240JB01#	p181
				±5%	GQM22M5C2H270GB01#	p181
			27pF	±2%	GQM22M5C2H270JB01#	p181
				±5%	GQM22M5C2H300GB01#	p181
			30pF	±2%	GQM22M5C2H300JB01#	p181
				±5%	GQM22M5C2H330GB01#	p181
			33pF	±2%	GQM22M5C2H330JB01#	p181
				±5%	GQM22M5C2H360GB01#	p181
			36pF	±2%	GQM22M5C2H360JB01#	p181
				±5%	GQM22M5C2H390GB01#	p181
			39pF	±2%	GQM22M5C2H390JB01#	p181
				±5%	GQM22M5C2H430GB01#	p181
			43pF	±2%	GQM22M5C2H430JB01#	p181
				±5%	GQM22M5C2H470GB01#	p181
			47pF	±2%	GQM22M5C2H470JB01#	p181
				±5%	GQM22M5C2H510GB01#	p181
			51pF	±2%	GQM22M5C2H510JB01#	p181
				±5%	GQM22M5C2H560GB01#	p181
			56pF	±2%	GQM22M5C2H560JB01#	p181
				±5%	GQM22M5C2H620GB01#	p181
			62pF	±2%	GQM22M5C2H620JB01#	p181
				±5%	GQM22M5C2H680GB01#	p181
68pF	±2%	GQM22M5C2H680GB01#	p181			

T max.	Rated Voltage	TC Code	Cap.	Tol.	Part Number	p*
1.35mm	500Vdc	COG	68pF	±5%	GQM22M5C2H680JB01#	p181
				±2%	GQM22M5C2H750GB01#	p181
			75pF	±2%	GQM22M5C2H750JB01#	p181
				±5%	GQM22M5C2H820GB01#	p181
			82pF	±2%	GQM22M5C2H820JB01#	p181
				±5%	GQM22M5C2H910GB01#	p181
			91pF	±2%	GQM22M5C2H910JB01#	p181
				±5%	GQM22M5C2H101GB01#	p181
			100pF	±2%	GQM22M5C2H101JB01#	p181
				±5%	GQM22M5C2H101JB01#	p181

*: Refers to the page of the "Specifications and Test Methods".

Part number # indicates the package specification code.

GRM
 GR3
 GRJ
 GRU
 GR4
 GR7
 GJM
 GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 ⚠Caution / Notice

1

GQM Series Specifications and Test Methods (1)

No	Item	Specification	Test Method (Ref. Standard: JIS C 5101, IEC60384)												
1	Rated Voltage	Shown in Rated value.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor. When AC voltage is superimposed on DC voltage, V^{P-P} or V^{O-P} , whichever is larger, should be maintained within the rated voltage range.												
2	Appearance	No defects or abnormalities.	Visual inspection.												
3	Dimension	Within the specified dimensions.	Using Measuring instrument of dimension.												
4	Voltage Proof	No defects or abnormalities.	Measurement Point: Between the terminations Applied Time: 1 to 5s Charge/discharge current: 50mA max. Test Voltage: <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>Rated Voltage</th> <th>Test Voltage</th> </tr> </thead> <tbody> <tr> <td>100V</td> <td>300% of Rated Voltage</td> </tr> <tr> <td>200V</td> <td>250% of Rated Voltage</td> </tr> </tbody> </table>	Rated Voltage	Test Voltage	100V	300% of Rated Voltage	200V	250% of Rated Voltage						
Rated Voltage	Test Voltage														
100V	300% of Rated Voltage														
200V	250% of Rated Voltage														
5	Insulation Resistance (I.R.)	More than 10000MΩ	Measurement Point: Between the terminations Measurement Voltage: DC Rated Voltage Charging Time: 2min Charge/discharge current: 50mA max. Measurement Temperature: Room Temperature												
6	Capacitance	Shown in Rated value.	Measurement Temperature: Room Temperature												
7	Q	30pF and over: $Q \geq 1400$ 30pF and below: $Q \geq 800+20C$ C: Nominal Capacitance(pF)	<table border="1" style="margin-left: 20px;"> <thead> <tr> <th>Capacitance</th> <th>Frequency</th> <th>Voltage</th> </tr> </thead> <tbody> <tr> <td>$C \leq 1000pF$</td> <td>1.0±0.1kHz</td> <td>0.5 to 5.0Vrms</td> </tr> </tbody> </table>	Capacitance	Frequency	Voltage	$C \leq 1000pF$	1.0±0.1kHz	0.5 to 5.0Vrms						
Capacitance	Frequency	Voltage													
$C \leq 1000pF$	1.0±0.1kHz	0.5 to 5.0Vrms													
8	Temperature Characteristics of Capacitance	Nominal values of the temperature coefficient is shown in Rated value. But, the Capacitance Change under 25°C is shown in Table A. Capacitance Drift Within ±0.2% or ±0.05pF (Whichever is larger.)	The capacitance change should be measured after 5 minutes at each specified temp. stage. Capacitance value as a reference is the value in step 3. The capacitance drift is calculated by dividing the differences between the maximum and minimum measured values in the step 1, 3 and 5 by the cap. value in step 3. <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>Step</th> <th>Temperature (°C)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Reference Temp. ±2</td> </tr> <tr> <td>2</td> <td>Min. Operating Temp. ±3</td> </tr> <tr> <td>3</td> <td>Reference Temp. ±2</td> </tr> <tr> <td>4</td> <td>Max. Operating Temp. ±3</td> </tr> <tr> <td>5</td> <td>Reference Temp. ±2</td> </tr> </tbody> </table>	Step	Temperature (°C)	1	Reference Temp. ±2	2	Min. Operating Temp. ±3	3	Reference Temp. ±2	4	Max. Operating Temp. ±3	5	Reference Temp. ±2
Step	Temperature (°C)														
1	Reference Temp. ±2														
2	Min. Operating Temp. ±3														
3	Reference Temp. ±2														
4	Max. Operating Temp. ±3														
5	Reference Temp. ±2														
9	Adhesive Strength of Termination	No removal of the terminations or other defect should occur.	Solder the capacitor on the test substrate shown in Fig.3. Applied Force: 5N Holding Time: 10±1s Applied Direction: In parallel with the test substrate and vertical with the capacitor side.												
10	Vibration	Appearance	No defects or abnormalities.												
		Capacitance	Within the specified initial value.												
		Q	Within the specified initial value.												
11	Substrate Bending Test	Appearance	No defects or abnormalities.												
		Capacitance Change	Within ±5% or ±0.5pF (Whichever is larger)												
12	Solderability	95% of the terminations is to be soldered evenly and continuously.	Test Method: Solder bath method Flux: Solution of rosin ethanol 25 (mass)% Preheat: 80 to 120°C for 10 to 30s Solder: Sn-3.0Ag-0.5Cu Solder Temp.: 245±5°C Immersion time: 2±0.5s												
13	Resistance to Soldering Heat	Appearance	No defects or abnormalities.												
		Capacitance Change	Within ±2.5% or ±0.25pF (Whichever is larger)												
		Q	Within the specified initial value.												
		I.R.	Within the specified initial value.												
		Voltage Proof	No defects.												

Continued on the following page. ↗

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
 GQM
 GA2
 GA3
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 GD
 GA3
 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 ⚠Caution /Notice

GQM Series Specifications and Test Methods (1)

Continued from the preceding page. ↘

No	Item	Specification	Test Method (Ref. Standard: JIS C 5101, IEC60384)															
14	Temperature Sudden Change	Appearance	Solder the capacitor on the test substrate shown in Fig.3. Perform the 5 cycles according to the four heat treatments shown in the following table. <table border="1" style="margin: 5px 0;"><thead> <tr> <th>Step</th> <th>Temp. (°C)</th> <th>Time (min)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Min. Operating Temp. +0/-3</td> <td>30±3</td> </tr> <tr> <td>2</td> <td>Room Temp.</td> <td>2 to 3</td> </tr> <tr> <td>3</td> <td>Max. Operating Temp. +3/-0</td> <td>30±3</td> </tr> <tr> <td>4</td> <td>Room Temp.</td> <td>2 to 3</td> </tr> </tbody> </table> Exposure Time: 24±2h	Step	Temp. (°C)	Time (min)	1	Min. Operating Temp. +0/-3	30±3	2	Room Temp.	2 to 3	3	Max. Operating Temp. +3/-0	30±3	4	Room Temp.	2 to 3
		Step		Temp. (°C)	Time (min)													
		1		Min. Operating Temp. +0/-3	30±3													
		2		Room Temp.	2 to 3													
		3		Max. Operating Temp. +3/-0	30±3													
4	Room Temp.	2 to 3																
Capacitance Change	Within ±2.5% or ±0.25pF (Whichever is larger)																	
Q	Within the specified initial value.																	
I.R.	Within the specified initial value.																	
Voltage Proof	No defects.																	
15	High Temperature High Humidity (Steady)	Appearance	Solder the capacitor on the test substrate shown in Fig.3. Test Temperature: 40±2°C Test Humidity: 90 to 95%RH Test Time: 500±12h Applied Voltage: DC Rated Voltage Charge/discharge current: 50mA max. Exposure Time: 24±2h															
		Capacitance Change		Within ±7.5% or ±0.75pF (Whichever is larger)														
		Q		30pF and over: $Q \geq 200$ 30pF and below: $Q \geq 100+10C/3$ C: Nominal Capacitance(pF)														
		I.R.		More than 500MΩ														
16	Durability	Appearance	Solder the capacitor on the test substrate shown in Fig.3. Test Temperature: Max. Operating Temp. ±3°C Test Time: 1000±12h Applied Voltage: 200% of the rated voltage Charge/discharge current: 50mA max. Exposure Time: 24±2h															
		Capacitance Change		Within ±3% or ±0.3pF (Whichever is larger)														
		Q		30pF and over: $Q \geq 350$ 10pF and over, 30pF and below: $Q \geq 275+5C/2$ 10pF and below: $Q \geq 200+10C$ C: Nominal Capacitance (pF)														
		I.R.		More than 1000MΩ														

Table A

Char.	Capacitance Change from 25°C(%)					
	-55°C		-30°C		-10°C	
	Max.	Min.	Max.	Min.	Max.	Min.
5C	0.58	-0.24	0.40	-0.17	0.25	-0.11

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GRM
 GR3
 GRJ
 GRU
 GR4
 GR7
 GJM
GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
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 NFM
 KPM
 KR3
 GMA
 GMD
 ⚠Caution / Notice

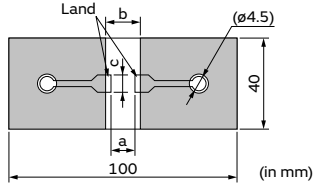
GQM Series Specifications and Test Methods (1)

Continued from the preceding page. ↘

Substrate Bending Test

• Test Substrate

Material: Copper-clad laminated sheets for PCBs (Glass fabric base, epoxy resin)
 Thickness: 0.8mm
 Copper foil thickness: 0.035mm
 [Shaded Area]: Solder resist (Coat with heat resistant resin for solder)



Part Number	Dimension (mm)		
	a	b	c
GQM15	0.4	1.5	0.5

Fig.1

- Kind of Solder: Sn-3.0Ag-0.5Cu
- Pressurization Method

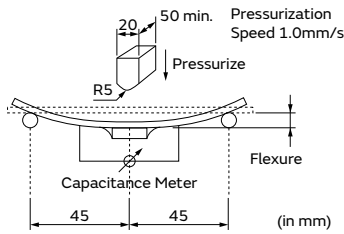


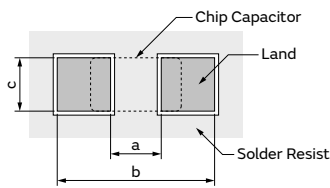
Fig.2

Adhesive Strength of Termination, Vibration, Temperature Sudden Change, High Temperature High Humidity (Steady) , Durability

• Test Substrate

Material: Copper-clad laminated sheets for PCBs (Glass fabric base, epoxy resin)
 Thickness: 1.6mm or 0.8mm
 Copper foil thickness: 0.035mm

- Kind of Solder: Sn-3.0Ag-0.5Cu
- Land Dimensions



Part Number	Dimension (mm)		
	a	b	c
GQM15	0.4	1.5	0.5

Fig.3

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 ⚠Caution /Notice

2

GQM Series Specifications and Test Methods (2)

No	Item	Specification	Test Method (Ref. Standard: JIS C 5101, IEC60384)												
1	Rated Voltage	Shown in Rated value.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor. When AC voltage is superimposed on DC voltage, V^{P-P} or V^{O-P} , whichever is larger, should be maintained within the rated voltage range.												
2	Appearance	No defects or abnormalities.	Visual inspection.												
3	Dimension	Within the specified dimensions.	Using Measuring instrument of dimension.												
4	Voltage Proof	No defects or abnormalities.	Measurement Point: Between the terminations Test Voltage : 250% of the rated voltage Applied Time: 1 to 5s Charge/discharge current: 50mA max.												
5	Insulation Resistance (I.R.)	More than 10000MΩ	Measurement Point: Between the terminations Measurement Voltage: DC Rated Voltage Charging Time: 1min Charge/discharge current: 50mA max. Measurement Temperature: Room Temperature												
6	Capacitance	Shown in Rated value.	Measurement Temperature :Room Temperature <table border="1"> <thead> <tr> <th>Capacitance</th> <th>Frequency</th> <th>Voltage</th> </tr> </thead> <tbody> <tr> <td>$C \leq 1000\text{pF}$</td> <td>1.0±0.1MHz</td> <td>0.5 to 5.0Vrms</td> </tr> </tbody> </table>	Capacitance	Frequency	Voltage	$C \leq 1000\text{pF}$	1.0±0.1MHz	0.5 to 5.0Vrms						
Capacitance	Frequency	Voltage													
$C \leq 1000\text{pF}$	1.0±0.1MHz	0.5 to 5.0Vrms													
7	Q	30pF and over: $Q \geq 1400$ 30pF and below: $Q \geq 800+20C$ C: Nominal Capacitance(pF)													
8	Temperature Characteristics of Capacitance	Nominal values of the temperature coefficient is shown in Rated value. But, the Capacitance Change under 20°C/25°C is shown in Table A. Capacitance Drift Within ±0.2% or ±0.05pF (Whichever is larger.)	The capacitance change should be measured after 5 minutes at each specified temp. stage. Capacitance value as a reference is the value in step 3. The capacitance drift is calculated by dividing the differences between the maximum and minimum measured values in the step 1, 3 and 5 by the cap. value in step 3. <table border="1"> <thead> <tr> <th>Step</th> <th>Temperature (°C)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Reference Temp. ±2</td> </tr> <tr> <td>2</td> <td>Min. Operating Temp. ±3</td> </tr> <tr> <td>3</td> <td>Reference Temp. ±2</td> </tr> <tr> <td>4</td> <td>Max. Operating Temp. ±3</td> </tr> <tr> <td>5</td> <td>Reference Temp. ±2</td> </tr> </tbody> </table>	Step	Temperature (°C)	1	Reference Temp. ±2	2	Min. Operating Temp. ±3	3	Reference Temp. ±2	4	Max. Operating Temp. ±3	5	Reference Temp. ±2
Step	Temperature (°C)														
1	Reference Temp. ±2														
2	Min. Operating Temp. ±3														
3	Reference Temp. ±2														
4	Max. Operating Temp. ±3														
5	Reference Temp. ±2														
9	Adhesive Strength of Termination	No removal of the terminations or other defect should occur.	Solder the capacitor on the test substrate shown in Fig.3. <table border="1"> <thead> <tr> <th>Part Number</th> <th>Applied Force(N)</th> </tr> </thead> <tbody> <tr> <td>GQM18</td> <td>5</td> </tr> <tr> <td>GQM21</td> <td>10</td> </tr> </tbody> </table> Holding Time: 10±1s Applied Direction: In parallel with the test substrate and vertical with the capacitor side.	Part Number	Applied Force(N)	GQM18	5	GQM21	10						
Part Number	Applied Force(N)														
GQM18	5														
GQM21	10														
10	Vibration	Appearance	Solder the capacitor on the test substrate shown in Fig.3. Kind of Vibration: A simple harmonic motion 10Hz to 55Hz to 10Hz (1min) Total amplitude: 1.5mm This motion should be applied for a period of 2h in each 3 mutually perpendicular directions (total of 6h).												
		Capacitance													
		Q													
11	Substrate Bending Test	Appearance	Solder the capacitor on the test substrate shown in Fig.1. Pressurization method: Shown in Fig.2 Flexure: 1mm Holding Time: 5±1s Soldering Method: Reflow soldering												
		Capacitance Change													
12	Solderability	95% of the terminations is to be soldered evenly and continuously.	Test Method: Solder bath method Flux: Solution of rosin ethanol 25 (mass)% Preheat: 80 to 120°C for 10 to 30s Solder: Sn-3.0Ag-0.5Cu Solder Temp.: 245±5°C Immersion time: 2±0.5s												

Continued on the following page. ↗

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KPM
 KR3
 GMA
 GMD
 ⚠Caution /Notice

GQM Series Specifications and Test Methods (2)

Continued from the preceding page. ↘

No	Item	Specification	Test Method (Ref. Standard: JIS C 5101, IEC60384)															
13	Resistance to Soldering Heat	Appearance	No defects or abnormalities.															
		Capacitance Change	Within $\pm 2.5\%$ or $\pm 0.25\text{pF}$ (Whichever is larger)															
		Q	Within the specified initial value.															
		I.R.	Within the specified initial value.															
		Voltage Proof	No defects.															
14	Temperature Sudden Change	Appearance	No defects or abnormalities.															
		Capacitance Change	Within $\pm 2.5\%$ or $\pm 0.25\text{pF}$ (Whichever is larger)															
		Q	Within the specified initial value.															
		I.R.	Within the specified initial value.															
		Voltage Proof	No defects.															
			Solder the capacitor on the test substrate shown in Fig.3. Perform the 5 cycles according to the four heat treatments shown in the following table. <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>Step</th> <th>Temp. (°C)</th> <th>Time (min)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Min. Operating Temp. +0/-3</td> <td>30±3</td> </tr> <tr> <td>2</td> <td>Room Temp.</td> <td>2 to 3</td> </tr> <tr> <td>3</td> <td>Max. Operating Temp. +3/-0</td> <td>30±3</td> </tr> <tr> <td>4</td> <td>Room Temp.</td> <td>2 to 3</td> </tr> </tbody> </table> Exposure Time: 24±2h	Step	Temp. (°C)	Time (min)	1	Min. Operating Temp. +0/-3	30±3	2	Room Temp.	2 to 3	3	Max. Operating Temp. +3/-0	30±3	4	Room Temp.	2 to 3
Step	Temp. (°C)	Time (min)																
1	Min. Operating Temp. +0/-3	30±3																
2	Room Temp.	2 to 3																
3	Max. Operating Temp. +3/-0	30±3																
4	Room Temp.	2 to 3																
15	High Temperature High Humidity (Steady)	Appearance	No defects or abnormalities.															
		Capacitance Change	Within $\pm 7.5\%$ or $\pm 0.75\text{pF}$ (Whichever is larger)															
		Q	30pF and over: $Q \geq 200$ 30pF and below: $Q \geq 100+10C/3$ C: Nominal Capacitance(pF)															
		I.R.	More than 500MΩ															
16	Durability	Appearance	No defects or abnormalities.															
		Capacitance Change	Within $\pm 3\%$ or $\pm 0.3\text{pF}$ (Whichever is larger)															
		Q	30pF and over: $Q \geq 350$ 10pF and over, 30pF and below: $Q \geq 275+5C/2$ 10pF and below: $Q \geq 200+10C$ C: Nominal Capacitance (pF)															
		I.R.	More than 1000MΩ															
			Solder the capacitor on the test substrate shown in Fig.3. Test Temperature: Max. Operating Temp. $\pm 3^\circ\text{C}$ Test Time: 1000±12h Applied Voltage: 200% of the rated voltage Charge/discharge current: 50mA max. Exposure Time: 24±2h															

Table A

Char.	Capacitance Change from 20°C/25°C (%)							
	-55°C		-30°C		-25°C		-10°C	
	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.
2C	0.82	-0.45	-	-	0.49	-0.27	0.33	-0.18
5C/5G	0.58	-0.24	0.40	-0.17	-	-	0.25	-0.11

Continued on the following page. ↗

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 ⚠Caution /Notice

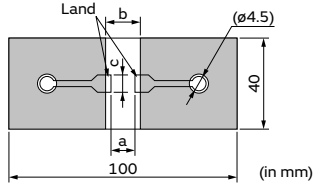
GQM Series Specifications and Test Methods (2)

Continued from the preceding page. ↘

Substrate Bending Test

• Test Substrate

Material: Copper-clad laminated sheets for PCBs (Glass fabric base, epoxy resin)
 Thickness: 1.6mm
 Copper foil thickness: 0.035mm
 [Shaded Area]: Solder resist (Coat with heat resistant resin for solder)



Part Number	Dimension (mm)		
	a	b	c
GQM18	1.0	3.0	1.2
GQM21	1.2	4.0	1.65

Fig.1

- Kind of Solder: Sn-3.0Ag-0.5Cu
- Pressurization Method

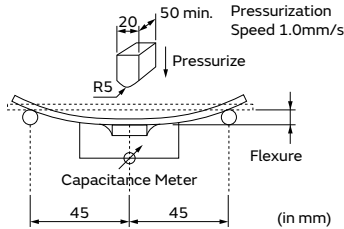


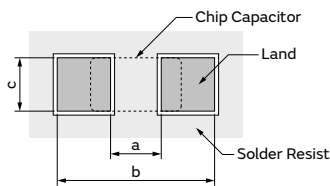
Fig.2

Adhesive Strength of Termination, Vibration, Temperature Sudden Change, High Temperature High Humidity (Steady) , Durability

• Test Substrate

Material: Copper-clad laminated sheets for PCBs (Glass fabric base, epoxy resin)
 Thickness: 1.6mm or 0.8mm
 Copper foil thickness: 0.035mm

- Kind of Solder: Sn-3.0Ag-0.5Cu
- Land Dimensions



Part Number	Dimension (mm)		
	a	b	c
GQM18	1.0	3.0	1.2
GQM21	1.2	4.0	1.65

Fig.3

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KPM
 KR3
 GMA
 GMD
 ⚠Caution / Notice

3

GQM Series Specifications and Test Methods (3)

No	Item	Specification	Test Method (Ref. Standard: JIS C 5101, IEC60384)												
1	Rated Voltage	Shown in Rated value.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor. When AC voltage is superimposed on DC voltage, V^{P-P} or V^{O-P} , whichever is larger, should be maintained within the rated voltage range.												
2	Appearance	No defects or abnormalities.	Visual inspection.												
3	Dimension	Within the specified dimensions.	Using Measuring instrument of dimension.												
4	Voltage Proof	No defects or abnormalities.	Measurement Point: Between the terminations Test Voltage: 250% of the rated voltage Applied Time: 1 to 5s Charge/discharge current: 50mA max.												
5	Insulation Resistance (I.R.)	More than 10000MΩ	Measurement Point: Between the terminations Measurement Voltage: DC Rated Voltage Charging Time: 2min Charge/discharge current: 50mA max. Measurement Temperature: Room Temperature												
6	Capacitance	Shown in Rated value.	Measurement Temperature: Room Temperature												
7	Q	30pF and over: $Q \geq 1400$ 30pF and below: $Q \geq 800+20C$ C: Nominal Capacitance (pF)	<table border="1"> <thead> <tr> <th>Capacitance</th> <th>Frequency</th> <th>Voltage</th> </tr> </thead> <tbody> <tr> <td>$C \leq 1000pF$</td> <td>$1.0 \pm 0.1kHz$</td> <td>0.5 to 5.0Vrms</td> </tr> </tbody> </table>	Capacitance	Frequency	Voltage	$C \leq 1000pF$	$1.0 \pm 0.1kHz$	0.5 to 5.0Vrms						
Capacitance	Frequency	Voltage													
$C \leq 1000pF$	$1.0 \pm 0.1kHz$	0.5 to 5.0Vrms													
8	Temperature Characteristics of Capacitance	Nominal values of the temperature coefficient is shown in Rated value. But, the Capacitance Change under 20°C/25°C is shown in Table A. Capacitance Drift Within $\pm 0.2\%$ or $\pm 0.05pF$ (Whichever is larger.)	The capacitance change should be measured after 5 minutes at each specified temp. stage. Capacitance value as a reference is the value in step 3. The capacitance drift is calculated by dividing the differences between the maximum and minimum measured values in the step 1, 3 and 5 by the cap. value in step 3. <table border="1"> <thead> <tr> <th>Step</th> <th>Temperature (°C)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Reference Temp. ± 2</td> </tr> <tr> <td>2</td> <td>Min. Operating Temp. ± 3</td> </tr> <tr> <td>3</td> <td>Reference Temp. ± 2</td> </tr> <tr> <td>4</td> <td>Max. Operating Temp. ± 3</td> </tr> <tr> <td>5</td> <td>Reference Temp. ± 2</td> </tr> </tbody> </table>	Step	Temperature (°C)	1	Reference Temp. ± 2	2	Min. Operating Temp. ± 3	3	Reference Temp. ± 2	4	Max. Operating Temp. ± 3	5	Reference Temp. ± 2
Step	Temperature (°C)														
1	Reference Temp. ± 2														
2	Min. Operating Temp. ± 3														
3	Reference Temp. ± 2														
4	Max. Operating Temp. ± 3														
5	Reference Temp. ± 2														
9	Adhesive Strength of Termination	No removal of the terminations or other defect should occur.	Solder the capacitor on the test substrate shown in Fig.3. <table border="1"> <thead> <tr> <th>Part Number</th> <th>Applied Force(N)</th> </tr> </thead> <tbody> <tr> <td>GQM18</td> <td>5</td> </tr> <tr> <td>GQM21</td> <td>10</td> </tr> </tbody> </table> Holding Time: 10±1s Applied Direction: In parallel with the test substrate and vertical with the capacitor side.	Part Number	Applied Force(N)	GQM18	5	GQM21	10						
Part Number	Applied Force(N)														
GQM18	5														
GQM21	10														
10	Vibration	<table border="1"> <tr> <td>Appearance</td> <td>No defects or abnormalities.</td> </tr> <tr> <td>Capacitance</td> <td>Within the specified initial value.</td> </tr> <tr> <td>Q</td> <td>Within the specified initial value.</td> </tr> </table>	Appearance	No defects or abnormalities.	Capacitance	Within the specified initial value.	Q	Within the specified initial value.	Solder the capacitor on the test substrate shown in Fig.3. Kind of Vibration: A simple harmonic motion 10Hz to 55Hz to 10Hz (1min) Total amplitude: 1.5mm This motion should be applied for a period of 2h in each 3 mutually perpendicular directions (total of 6h).						
Appearance	No defects or abnormalities.														
Capacitance	Within the specified initial value.														
Q	Within the specified initial value.														
11	Substrate Bending Test	<table border="1"> <tr> <td>Appearance</td> <td>No defects or abnormalities.</td> </tr> <tr> <td>Capacitance Change</td> <td>Within $\pm 5\%$ or $\pm 0.5pF$ (Whichever is larger)</td> </tr> </table>	Appearance	No defects or abnormalities.	Capacitance Change	Within $\pm 5\%$ or $\pm 0.5pF$ (Whichever is larger)	Solder the capacitor on the test substrate shown in Fig.1. Pressurization method: Shown in Fig.2 Flexure: 1mm Holding Time: 5±1s Soldering Method: Reflow soldering								
Appearance	No defects or abnormalities.														
Capacitance Change	Within $\pm 5\%$ or $\pm 0.5pF$ (Whichever is larger)														
12	Solderability	95% of the terminations is to be soldered evenly and continuously.	Test Method: Solder bath method Flux: Solution of rosin ethanol 25 (mass)% Preheat: 80 to 120°C for 10 to 30s Solder: Sn-3.0Ag-0.5Cu Solder Temp.: 245±5°C Immersion time: 2±0.5s												
13	Resistance to Soldering Heat	<table border="1"> <tr> <td>Appearance</td> <td>No defects or abnormalities.</td> </tr> <tr> <td>Capacitance Change</td> <td>Within $\pm 2.5\%$ or $\pm 0.25pF$ (Whichever is larger)</td> </tr> <tr> <td>Q</td> <td>Within the specified initial value.</td> </tr> <tr> <td>I.R.</td> <td>Within the specified initial value.</td> </tr> <tr> <td>Voltage Proof</td> <td>No defects.</td> </tr> </table>	Appearance	No defects or abnormalities.	Capacitance Change	Within $\pm 2.5\%$ or $\pm 0.25pF$ (Whichever is larger)	Q	Within the specified initial value.	I.R.	Within the specified initial value.	Voltage Proof	No defects.	Test Method: Solder bath method Solder: Sn-3.0Ag-0.5Cu Solder Temp.: 270±5°C Immersion time: 10±0.5s Exposure Time: 24±2h Preheat: 120 to 150°C for 1min		
Appearance	No defects or abnormalities.														
Capacitance Change	Within $\pm 2.5\%$ or $\pm 0.25pF$ (Whichever is larger)														
Q	Within the specified initial value.														
I.R.	Within the specified initial value.														
Voltage Proof	No defects.														

Continued on the following page. ↗

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
 GQM
 GA2
 GA3
 GB
 GA3
 GD
 GA3
 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 ⚠Caution /Notice

GQM Series Specifications and Test Methods (3)

Continued from the preceding page. ↘

No	Item	Specification	Test Method (Ref. Standard: JIS C 5101, IEC60384)															
14	Temperature Sudden Change	Appearance	Solder the capacitor on the test substrate shown in Fig.3. Perform the 5 cycles according to the four heat treatments shown in the following table. <table border="1" data-bbox="938 353 1375 483"> <thead> <tr> <th>Step</th> <th>Temp. (°C)</th> <th>Time (min)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Min. Operating Temp. +0/-3</td> <td>30±3</td> </tr> <tr> <td>2</td> <td>Room Temp.</td> <td>2 to 3</td> </tr> <tr> <td>3</td> <td>Max. Operating Temp. +3/-0</td> <td>30±3</td> </tr> <tr> <td>4</td> <td>Room Temp.</td> <td>2 to 3</td> </tr> </tbody> </table> Exposure Time: 24±2h	Step	Temp. (°C)	Time (min)	1	Min. Operating Temp. +0/-3	30±3	2	Room Temp.	2 to 3	3	Max. Operating Temp. +3/-0	30±3	4	Room Temp.	2 to 3
		Step		Temp. (°C)	Time (min)													
		1		Min. Operating Temp. +0/-3	30±3													
		2		Room Temp.	2 to 3													
		3		Max. Operating Temp. +3/-0	30±3													
4	Room Temp.	2 to 3																
Capacitance Change	Within ±2.5% or ±0.25pF (Whichever is larger)																	
Q	Within the specified initial value.																	
I.R.	Within the specified initial value.																	
Voltage Proof	No defects.																	
15	High Temperature High Humidity (Steady)	Appearance	Solder the capacitor on the test substrate shown in Fig.3. Test Temperature: 40±2°C Test Humidity: 90 to 95%RH Test Time: 500±12h Applied Voltage: DC Rated Voltage Charge/discharge current: 50mA max. Exposure Time: 24±2h															
		Capacitance Change		Within ±7.5% or ±0.75pF (Whichever is larger)														
		Q		30pF and over: Q ≥ 200 30pF and below: Q ≥ 100+10C/3 C: Nominal Capacitance(pF)														
		I.R.		More than 500MΩ														
16	Durability	Appearance	Solder the capacitor on the test substrate shown in Fig.3. Test Temperature: Max. Operating Temp. ±3°C Test Time: 1000±12h Applied Voltage: 200% of the rated voltage Charge/discharge current: 50mA max. Exposure Time: 24±2h															
		Capacitance Change		Within ±3% or ±0.3pF (Whichever is larger)														
		Q		30pF and over: Q ≥ 350 10pF and over, 30pF and below: Q ≥ 275+5C/2 10pF and below: Q ≥ 200+10C C: Nominal Capacitance (pF)														
		I.R.		More than 1000MΩ														

Table A

Char.	Capacitance Change from 20°C/25°C (%)							
	-55°C		-30°C		-25°C		-10°C	
	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.
2C	0.82	-0.45	-	-	0.49	-0.27	0.33	-0.18
5C/5G	0.58	-0.24	0.40	-0.17	-	-	0.25	-0.11

Continued on the following page. ↗

GRM
 GR3
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 GJM
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 GA2
 GA3 GB
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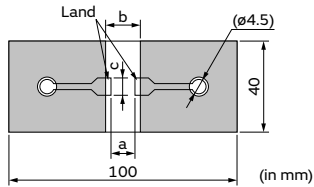
GQM Series Specifications and Test Methods (3)

Continued from the preceding page. ↘

Substrate Bending Test

• Test Substrate

Material: Copper-clad laminated sheets for PCBs (Glass fabric base, epoxy resin)
 Thickness: 1.6mm
 Copper foil thickness: 0.035mm
 [Shaded Area]: Solder resist (Coat with heat resistant resin for solder)



Part Number	Dimension (mm)		
	a	b	c
GQM18	1.0	3.0	1.2
GQM21	1.2	4.0	1.65

Fig.1

- Kind of Solder: Sn-3.0Ag-0.5Cu
- Pressurization Method

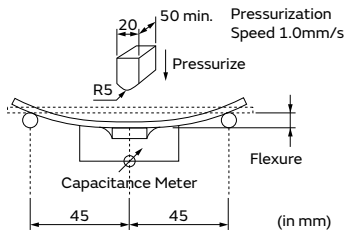


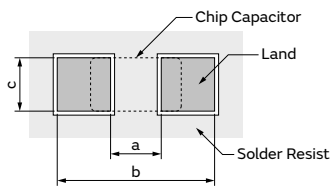
Fig.2

Adhesive Strength of Termination, Vibration, Temperature Sudden Change, High Temperature High Humidity (Steady) , Durability

• Test Substrate

Material: Copper-clad laminated sheets for PCBs (Glass fabric base, epoxy resin)
 Thickness: 1.6mm or 0.8mm
 Copper foil thickness: 0.035mm

- Kind of Solder: Sn-3.0Ag-0.5Cu
- Land Dimensions



Part Number	Dimension (mm)		
	a	b	c
GQM18	1.0	3.0	1.2
GQM21	1.2	4.0	1.65

Fig.3

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 ⚠Caution /Notice

4

GQM Series Specifications and Test Methods (4)

No	Item	Specification	Test Method (Ref. Standard: JIS C 5101, IEC60384)												
1	Rated Voltage	Shown in Rated value.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor. When AC voltage is superimposed on DC voltage, V^{P-P} or V^{O-P} , whichever is larger, should be maintained within the rated voltage range.												
2	Appearance	No defects or abnormalities.	Visual inspection.												
3	Dimension	Within the specified dimensions.	Using Measuring instrument of dimension.												
4	Voltage Proof	No defects or abnormalities.	Measurement Point: Between the terminations Test Voltage: 250% of the rated voltage Applied Time: 1 to 5s Charge/discharge current: 50mA max.												
5	Insulation Resistance (I.R.)	More than 10000MΩ	Measurement Point: Between the terminations Measurement Voltage: DC Rated Voltage Charging Time: 2min Charge/discharge current: 50mA max. Measurement Temperature: Room Temperature												
6	Capacitance	Shown in Rated value.	Measurement Temperature: Room Temperature <table border="1"> <thead> <tr> <th>Capacitance</th> <th>Frequency</th> <th>Voltage</th> </tr> </thead> <tbody> <tr> <td>$C \leq 1000\text{pF}$</td> <td>1.0±0.1kHz</td> <td>0.5 to 5.0Vrms</td> </tr> </tbody> </table>	Capacitance	Frequency	Voltage	$C \leq 1000\text{pF}$	1.0±0.1kHz	0.5 to 5.0Vrms						
Capacitance	Frequency	Voltage													
$C \leq 1000\text{pF}$	1.0±0.1kHz	0.5 to 5.0Vrms													
7	Q	30pF and over: $Q \geq 1400$ 30pF and below: $Q \geq 800+20C$ C: Nominal Capacitance(pF)													
8	Temperature Characteristics of Capacitance	Nominal values of the temperature coefficient is shown in Rated value. But, the Capacitance Change under 25°C is shown in Table A. Capacitance Drift Within ±0.2% or ±0.05pF (Whichever is larger.)	The capacitance change should be measured after 5 minutes at each specified temp. stage. Capacitance value as a reference is the value in step 3. The capacitance drift is calculated by dividing the differences between the maximum and minimum measured values in the step 1, 3 and 5 by the cap. value in step 3. <table border="1"> <thead> <tr> <th>Step</th> <th>Temperature (°C)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Reference Temp. ±2</td> </tr> <tr> <td>2</td> <td>Min. Operating Temp. ±3</td> </tr> <tr> <td>3</td> <td>Reference Temp. ±2</td> </tr> <tr> <td>4</td> <td>Max. Operating Temp. ±3</td> </tr> <tr> <td>5</td> <td>Reference Temp. ±2</td> </tr> </tbody> </table>	Step	Temperature (°C)	1	Reference Temp. ±2	2	Min. Operating Temp. ±3	3	Reference Temp. ±2	4	Max. Operating Temp. ±3	5	Reference Temp. ±2
Step	Temperature (°C)														
1	Reference Temp. ±2														
2	Min. Operating Temp. ±3														
3	Reference Temp. ±2														
4	Max. Operating Temp. ±3														
5	Reference Temp. ±2														
9	Adhesive Strength of Termination	No removal of the terminations or other defect should occur.	Solder the capacitor on the test substrate shown in Fig.3. Applied Force: 10N Holding Time: 10±1s Applied Direction: In parallel with the test substrate and vertical with the capacitor side.												
10	Vibration	Appearance	Solder the capacitor on the test substrate shown in Fig.3. Kind of Vibration: A simple harmonic motion 10Hz to 55Hz to 10Hz (1min) Total amplitude: 1.5mm This motion should be applied for a period of 2h in each 3 mutually perpendicular directions (total of 6h).												
		Capacitance													
		Q													
11	Substrate Bending Test	Appearance	Solder the capacitor on the test substrate shown in Fig.1. Pressurization method: Shown in Fig.2 Flexure:1mm Holding Time: 5±1s Soldering Method: Reflow soldering												
		Capacitance Change													
12	Solderability	95% of the terminations is to be soldered evenly and continuously.	Test Method: Solder bath method Flux: Solution of rosin ethanol 25 (mass)% Preheat: 80 to 120°C for 10 to 30s Solder: Sn-3.0Ag-0.5Cu Solder Temp.: 245±5°C Immersion time: 2±0.5s												
13	Resistance to Soldering Heat	Appearance	Test Method: Solder bath method Solder: Sn-3.0Ag-0.5Cu Solder Temp.: 270±5°C Immersion time: 10±0.5s Exposure Time: 24±2h Preheat: 120 to 150°C for 1min												
		Capacitance Change													
		Q													
		I.R.													
		Voltage Proof													

Continued on the following page. ➤

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
 GQM
 GA2
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GQM Series Specifications and Test Methods (4)

Continued from the preceding page. ↘

No	Item	Specification	Test Method (Ref. Standard: JIS C 5101, IEC60384)															
14	Appearance	No defects or abnormalities.	Solder the capacitor on the test substrate shown in Fig.3. Perform the 5 cycles according to the four heat treatments shown in the following table. <table border="1" style="margin: 10px 0;"> <thead> <tr> <th>Step</th> <th>Temp. (°C)</th> <th>Time (min)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Min. Operating Temp. +0/-3</td> <td>30±3</td> </tr> <tr> <td>2</td> <td>Room Temp.</td> <td>2 to 3</td> </tr> <tr> <td>3</td> <td>Max. Operating Temp. +3/-0</td> <td>30±3</td> </tr> <tr> <td>4</td> <td>Room Temp.</td> <td>2 to 3</td> </tr> </tbody> </table> Exposure Time: 24±2h	Step	Temp. (°C)	Time (min)	1	Min. Operating Temp. +0/-3	30±3	2	Room Temp.	2 to 3	3	Max. Operating Temp. +3/-0	30±3	4	Room Temp.	2 to 3
	Step	Temp. (°C)		Time (min)														
	1	Min. Operating Temp. +0/-3		30±3														
	2	Room Temp.		2 to 3														
	3	Max. Operating Temp. +3/-0		30±3														
4	Room Temp.	2 to 3																
Capacitance Change	Within ±2.5% or ±0.25pF (Whichever is larger)																	
Q	Within the specified initial value.																	
I.R.	Within the specified initial value.																	
Voltage Proof	No defects.																	
15	Appearance	No defects or abnormalities.	Solder the capacitor on the test substrate shown in Fig.3. Test Temperature: 40±2°C Test Humidity: 90 to 95%RH Test Time: 500±12h Applied Voltage: DC Rated Voltage Charge/discharge current: 50mA max. Exposure Time: 24±2h															
	Capacitance Change	Within ±7.5% or ±0.75pF (Whichever is larger)																
	Q	30pF and over: Q ≥ 200 30pF and below: Q ≥ 100+10C/3 C: Nominal Capacitance(pF)																
	I.R.	More than 500MΩ																
16	Appearance	No defects or abnormalities.	Solder the capacitor on the test substrate shown in Fig.3. Test Temperature: Max. Operating Temp. ±3°C Test Time: 1000±12h Applied Voltage: 150% of the rated voltage Charge/discharge current: 50mA max. Exposure Time: 24±2h															
	Capacitance Change	Within ±3% or ±0.3pF (Whichever is larger)																
	Q	30pF and over: Q ≥ 350 10pF and over, 30pF and below: Q ≥ 275+5C/2 10pF and below: Q ≥ 200+10C C: Nominal Capacitance (pF)																
	I.R.	More than 1000MΩ																

Table A

Char.	Capacitance Change from 25°C(%)					
	-55°C		-30°C		-10°C	
	Max.	Min.	Max.	Min.	Max.	Min.
5C	0.58	-0.24	0.40	-0.17	0.25	-0.11

Continued on the following page. ↗


GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 ⚠Caution /Notice

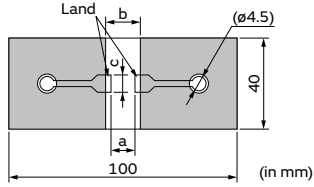
GQM Series Specifications and Test Methods (4)

Continued from the preceding page. ↘

Substrate Bending Test

• Test Substrate

Material: Copper-clad laminated sheets for PCBs (Glass fabric base, epoxy resin)
 Thickness: 1.6mm
 Copper foil thickness: 0.035mm
 : Solder resist (Coat with heat resistant resin for solder)



Part Number	Dimension (mm)		
	a	b	c
GQM22	2.2	5.0	2.9

Fig.1

- Kind of Solder: Sn-3.0Ag-0.5Cu
- Pressurization Method

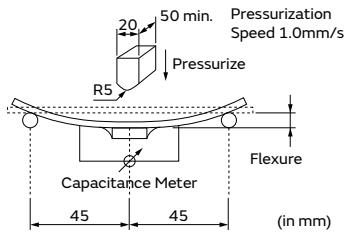


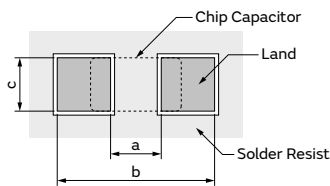
Fig.2

Adhesive Strength of Termination, Vibration, Temperature Sudden Change, High Temperature High Humidity (Steady) , Durability

• Test Substrate

Material: Copper-clad laminated sheets for PCBs (Glass fabric base, epoxy resin)
 Thickness: 1.6mm or 0.8mm
 Copper foil thickness: 0.035mm

- Kind of Solder: Sn-3.0Ag-0.5Cu
- Land Dimensions



Part Number	Dimension (mm)		
	a	b	c
GQM22	2.2	5.0	2.9

Fig.3

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KPM
 KR3
 GMA
 GMD
 ⚠Caution / Notice

**GRM, GR3, GRJ, GR4, GR7, GJM,
 GQM, GA2, GA3, LLL, LLA, LLM,
 LLR, NFM, KRM, KR3, GMA, GMD**

⚠️Caution/Notice



⚠️Caution

Notice

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- GR7
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- GQM
- GA2
- GA3 GB
- GA3 GD
- GA3 GF
- LLL
- LLA
- LLM
- LLR
- NFM
- KRM
- KR3
- GMA
- GMD
- ⚠️Caution /Notice

Caution

Storage and Operation Conditions

1. The performance of chip multilayer ceramic capacitors and chip EMIFIL NFM series (henceforth just “capacitors”) may be affected by the storage conditions.

Please use them promptly after delivery.

1-1. Maintain appropriate storage for the capacitors using the following conditions: Room Temperature of +5 to +40°C and a Relative Humidity of 20 to 70%.

High temperature and humidity conditions and/or prolonged storage may cause deterioration of the packaging materials. If more than six months have elapsed since delivery, check packaging, mounting, etc. before use.

In addition, this may cause oxidation of the electrodes. If more than one year has elapsed since delivery, also check the solderability before use.

1-2. Corrosive gas can react with the termination (external) electrodes or lead wires of capacitors, and result in poor solderability. Do not store the capacitors in an atmosphere consisting of corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas, etc.).

1-3. Due to moisture condensation caused by rapid humidity changes, or the photochemical change caused by direct sunlight on the terminal electrodes and/or the resin/epoxy coatings, the solderability and electrical performance may deteriorate. Do not store capacitors under direct sunlight or in high humidity conditions.

Rating

1. Temperature Dependent Characteristics

1. The electrical characteristics of a capacitor can change with temperature.

1-1. For capacitors having larger temperature dependency, the capacitance may change with temperature changes.

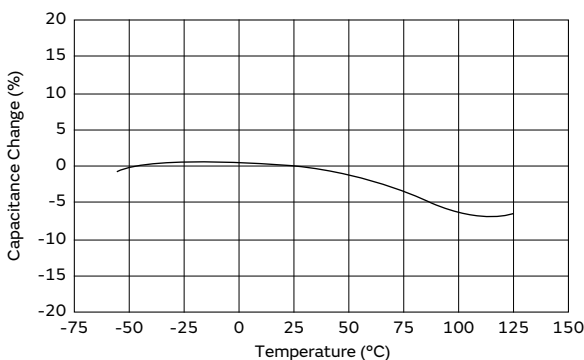
The following actions are recommended in order to ensure suitable capacitance values.

(1) Select a suitable capacitance for the operating temperature range.

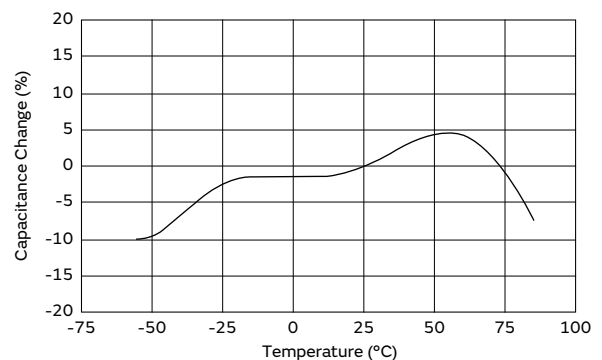
(2) The capacitance may change within the rated temperature.

When you use a high dielectric constant type capacitor in a circuit that needs a tight (narrow) capacitance tolerance (e.g., a time-constant circuit), please carefully consider the temperature characteristics, and carefully confirm the various characteristics in actual use conditions and the actual system.

[Example of Temperature Characteristics X7R (R7)]
 Sample: 0.1μF, Rated Voltage 50VDC



[Example of Temperature Characteristics X5R (R6)]
 Sample: 22μF, Rated Voltage 4VDC



2. Measurement of Capacitance

1. Measure capacitance with the voltage and frequency specified in the product specifications.

1-1. The output voltage of the measuring equipment may decrease occasionally when capacitance is high. Please confirm whether a prescribed measured voltage is impressed to the capacitor.

1-2. The capacitance values of high dielectric constant type capacitors change depending on the AC voltage applied. Please consider the AC voltage characteristics when selecting a capacitor to be used in an AC circuit.

Continued on the following page. ↗

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
 GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 △Caution

Caution

Continued from the preceding page. ↘

3. Applied Voltage and Applied Current

1. Do not apply a voltage to the capacitor that exceeds the rated voltage as called out in the specifications.
 - 1-1. Applied voltage between the terminals of a capacitor shall be less than or equal to the rated voltage.
 - (1) When AC voltage is superimposed on DC voltage, the zero-to-peak voltage shall not exceed the rated DC voltage.
 When AC voltage or pulse voltage is applied, the peak-to-peak voltage shall not exceed the rated DC voltage.
 - (2) Abnormal voltages (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated DC voltage.

Typical Voltage Applied to the DC Capacitor



(E: Maximum possible applied voltage.)

- 1-2. Influence of over voltage
 Over voltage that is applied to the capacitor may result in an electrical short circuit caused by the breakdown of the internal dielectric layers. The time duration until breakdown depends on the applied voltage and the ambient temperature.
2. Use a safety standard certified capacitor in a power supply input circuit (AC filter), as it is also necessary to consider the withstand voltage and impulse withstand voltage defined for each device.

4. Type of Applied Voltage and Self-heating Temperature

1. Confirm the operating conditions to make sure that no large current is flowing into the capacitor due to the continuous application of an AC voltage or pulse voltage.
 When a DC rated voltage product is used in an AC voltage circuit or a pulse voltage circuit, the AC current or pulse current will flow into the capacitor; therefore check the self-heating condition.
 Please confirm the surface temperature of the capacitor so that the temperature remains within the upper limits of the operating temperature, including the rise in temperature due to self-heating. When the capacitor is used with a high-frequency voltage or pulse voltage, heat may be generated by dielectric loss.
<Applicable to Rated Voltage of less than 100VDC>
 - 1-1. The load should be contained so that the self-heating of the capacitor body remains below 20°C, when measuring at an ambient temperature of 25°C.

<Applicable to NFM Series>

3. The capacitors also have rated currents.
 The current flowing between the terminals of a capacitor shall be less than or equal to the rated current. Using the capacitor beyond this range could lead to excessive heat.



Continued on the following page. ↗

⚠Caution

Continued from the preceding page. ↘

<Applicable to Temperature Characteristics X7R (R7), X7T (D7), X7T (W0) beyond Rated Voltage of 200VDC>

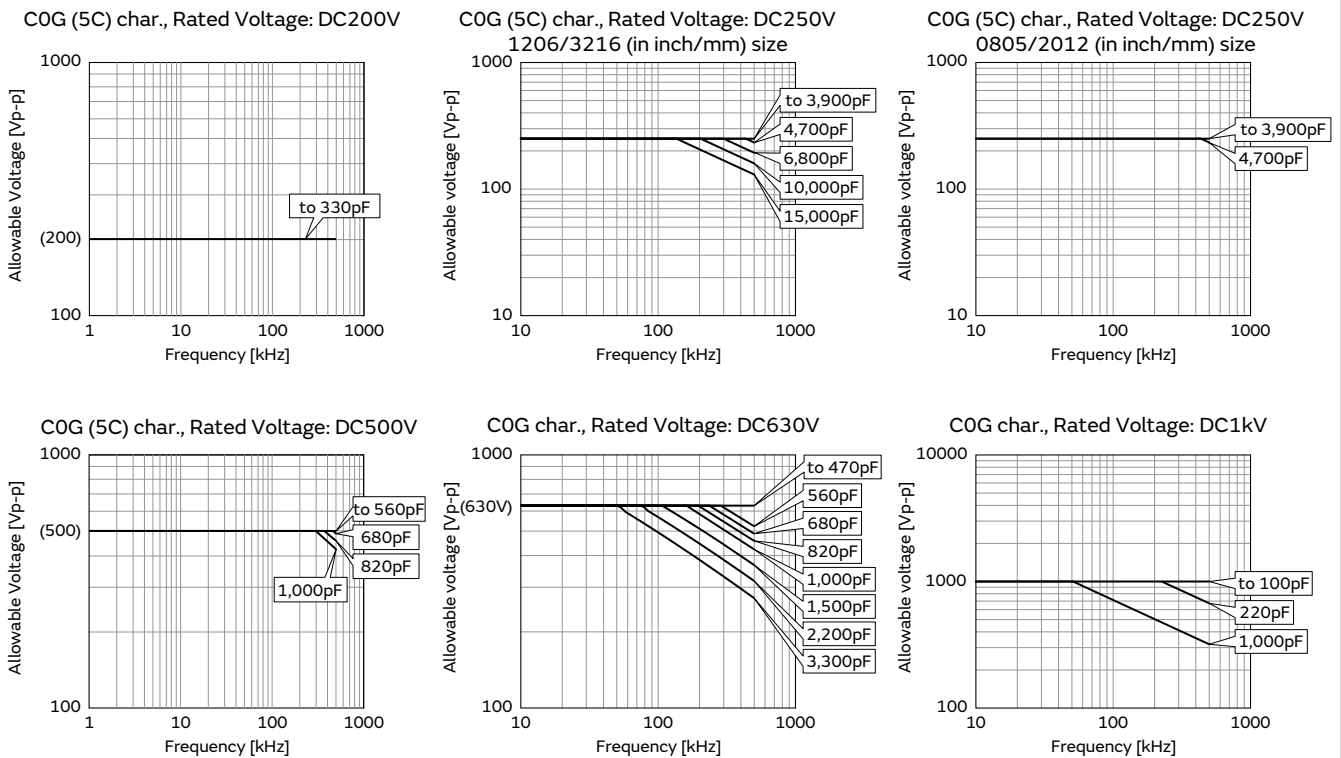
1-2. The load should be contained so that the self-heating of the capacitor body remains below 20°C, when measuring at an ambient temperature of 25°C. In addition, use a K thermocouple of \varnothing 0.1mm with less heat capacity when measuring, and measure in a condition where there is no effect from the radiant heat of other components or air flow caused by convection. Excessive generation of heat may cause deterioration of the characteristics and reliability of the capacitor. (Absolutely do not perform measurements while the cooling fan is operating, as an accurate measurement may not be performed.)

<Applicable to Temperature Characteristics U2J (7U), COG (5C) beyond Rated Voltage of 200VDC>

1-3. Since the self-heating is low in the low loss series, the allowable power becomes extremely high compared to the common X7R (R7) characteristics. However, when a load with self-heating of 20°C is applied at the rated voltage, the allowable power may be exceeded. When the capacitor is used in a high-frequency voltage circuit of 1kHz or more, the frequency of the applied voltage should be less than 500kHz sine wave (less than 100kHz for a product with rated voltage of DC3.15kV), to limit the voltage load so that the load remains within the derating shown in the following figure. In the case of non-sine wave, high-frequency components exceeding the fundamental frequency may be included. In such a case, please contact Murata. The excessive generation of heat may cause deterioration of the characteristics and reliability of the capacitor. (Absolutely do not perform measurements while the cooling fan is operating, as an accurate measurement may not be performed.)

[The sine-wave frequency VS allowable voltage]

The surface temperature of the capacitor: 125°C or less (including self-heating)



Continued on the following page. ↗

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
 GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLLA
 LLLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 ⚠Caution

⚠Caution

Continued from the preceding page. ↘

[The sine-wave frequency VS allowable voltage]

The surface temperature of the capacitor: 125°C or less
 (including self-heating)



Continued on the following page. ↗

- GRM
- GR3
- GRJ
- GR4
- GR7
- GJM
- GQM
- GA2
- GA3 GB
- GA3 GD
- GA3 GF
- LLL
- LLA
- LLM
- LLR
- NFM
- KRM
- KR3
- GMA
- GMD
- ⚠Caution

⚠Caution

Continued from the preceding page. ↘

5. DC Voltage and AC Voltage Characteristics

1. The capacitance value of a high dielectric constant type capacitor changes depending on the DC voltage applied. Please consider the DC voltage characteristics when a capacitor is selected for use in a DC circuit.

1-1. The capacitance of ceramic capacitors may change sharply depending on the applied voltage (see figure). Please confirm the following in order to secure the capacitance.

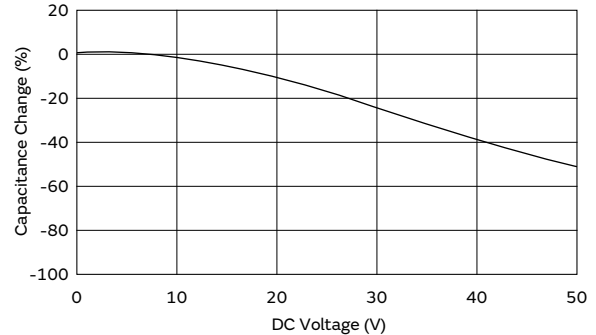
- (1) Determine whether the capacitance change caused by the applied voltage is within the allowed range.
- (2) In the DC voltage characteristics, the rate of capacitance change becomes larger as voltage increases, even if the applied voltage is below the rated voltage. When a high dielectric constant type capacitor is used in a circuit that requires a tight (narrow) capacitance tolerance (e.g., a time constant circuit), please carefully consider the voltage characteristics, and confirm the various characteristics in the actual operating conditions of the system.

2. The capacitance values of high dielectric constant type capacitors changes depending on the AC voltage applied. Please consider the AC voltage characteristics when selecting a capacitor to be used in an AC circuit.

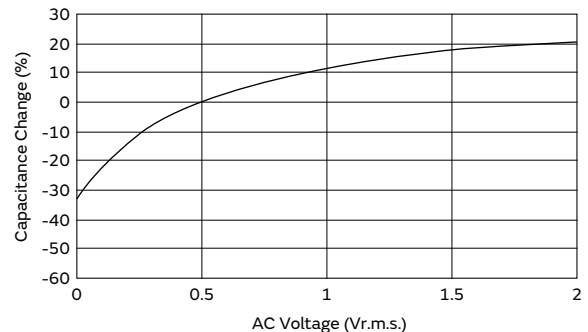
6. Capacitance Aging

1. The high dielectric constant type capacitors have an Aging characteristic in which the capacitance value decreases with the passage of time. When you use high dielectric constant type capacitors in a circuit that needs a tight (narrow) capacitance tolerance (e.g., a time-constant circuit), please carefully consider the characteristics of these capacitors, such as their aging, voltage, and temperature characteristics. In addition, check capacitors using your actual appliances at the intended environment and operating conditions.

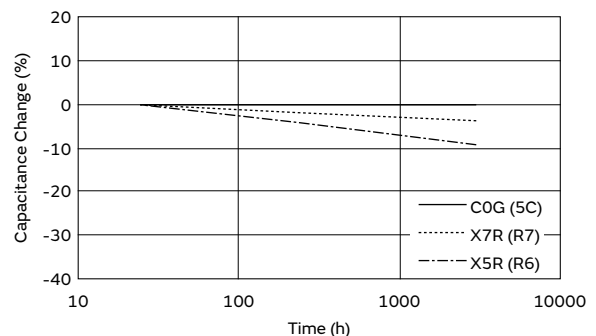
[Example of DC Voltage Characteristics]
 Sample: X7R (R7) Characteristics 0.1μF,
 Rated Voltage 50VDC



[Example of AC Voltage Characteristics]
 Sample: X7R (R7) Characteristics 10μF,
 Rated Voltage 6.3VDC



[Example of Change Over Time (Aging Characteristics)]



Continued on the following page. ↗

GRM

GR3

GRJ

GR4

GR7

GJM

GQM

GA2

GA3
GB

GA3
GD

GA3
GF

LLL

LLA

LLM

LLR

NFM

KRM

KR3

GMA

GMD

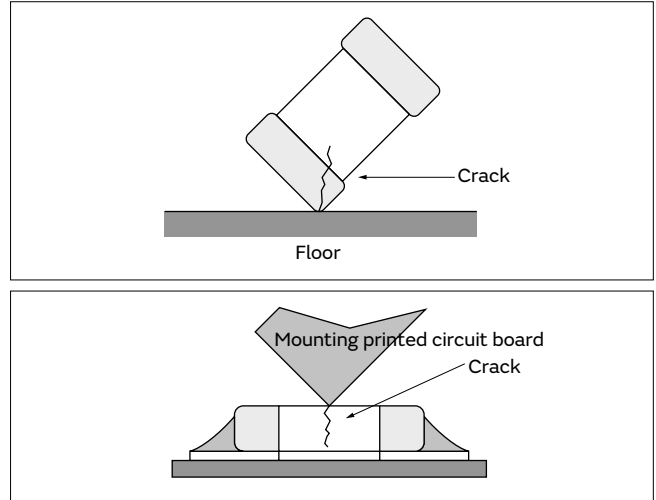
⚠Caution

⚠Caution

Continued from the preceding page. ↘

7. Vibration and Shock

1. Please confirm the kind of vibration and/or shock, its condition, and any generation of resonance.
 Please mount the capacitor so as not to generate resonance, and do not allow any impact on the terminals.
2. Mechanical shock due to being dropped may cause damage or a crack in the dielectric material of the capacitor.
 Do not use a dropped capacitor because the quality and reliability may be deteriorated.
3. When printed circuit boards are piled up or handled, the corner of another printed circuit board should not be allowed to hit the capacitor, in order to avoid a crack or other damage to the capacitor.



Soldering and Mounting

1. Mounting Position

1. Confirm the best mounting position and direction that minimizes the stress imposed on the capacitor during flexing or bending the printed circuit board.
 - 1-1. Choose a mounting position that minimizes the stress imposed on the chip during flexing or bending of the board.

<Applicable to NFM Series>

2. If you mount the capacitor near components that generate heat, take note of the heat from the other components and carefully check the self-heating of the capacitor before using.
 If there is significant heat radiation from other components, it could lower the insulation resistance of the capacitor or produce excessive heat.

[Component Direction]

[Chip Mounting Close to Board Separation Point]

It is effective to implement the following measures, to reduce stress in separating the board.
 It is best to implement all of the following three measures; however, implement as many measures as possible to reduce stress.

Contents of Measures	Stress Level
(1) Turn the mounting direction of the component parallel to the board separation surface.	A > D *1
(2) Add slits in the board separation part.	A > B
(3) Keep the mounting position of the component away from the board separation surface.	A > C

*1 A > D is valid when stress is added vertically to the perforation as with Hand Separation.
 If a Cutting Disc is used, stress will be diagonal to the PCB, therefore A > D is invalid.

[Mounting Capacitors Near Screw Holes]

When a capacitor is mounted near a screw hole, it may be affected by the board deflection that occurs during the tightening of the screw. Mount the capacitor in a position as far away from the screw holes as possible.

Continued on the following page. ↗

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
 GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KPM
 KR3
 GMA
 GMD
 ⚠Caution

⚠Caution

Continued from the preceding page. ↘

2. Information before Mounting

1. Do not re-use capacitors that were removed from the equipment.
2. Confirm capacitance characteristics under actual applied voltage.
3. Confirm the mechanical stress under actual process and equipment use.
4. Confirm the rated capacitance, rated voltage and other electrical characteristics before assembly.
5. Prior to use, confirm the solderability of capacitors that were in long-term storage.
6. Prior to measuring capacitance, carry out a heat treatment for capacitors that were in long-term storage.
7. The use of Sn-Zn based solder will deteriorate the reliability of the MLCC.
Please contact our sales representative or product engineers on the use of Sn-Zn based solder in advance.
8. We have also produced a DVD which shows a summary of our recommendations, regarding the precautions for mounting. Please contact our sales representative to request the DVD.

3. Maintenance of the Mounting (pick and place) Machine

1. Make sure that the following excessive forces are not applied to the capacitors. Check the mounting in the actual device under actual use conditions ahead of time.
 - 1-1. In mounting the capacitors on the printed circuit board, any bending force against them shall be kept to a minimum to prevent them from any damage or cracking. Please take into account the following precautions and recommendations for use in your process.
 - (1) Adjust the lowest position of the pickup nozzle so as not to bend the printed circuit board.
2. Dirt particles and dust accumulated in the suction nozzle and suction mechanism prevent the nozzle from moving smoothly. This creates excessive force on the capacitor during mounting, causing cracked chips. Also, the locating claw, when worn out, imposes uneven forces on the chip when positioning, causing cracked chips. The suction nozzle and the locating claw must be maintained, checked, and replaced periodically.

<Applicable to ZRB Series>

3. To adjust the inspection tolerance for automated appearance sorting machine of mounting position, because ZRB series are easier to shift the mounting position than standard MLCC.
4. To check the overturn and reverse of chip.
5. To control mounting speed carefully, because ZRB series is heavier than standard MLCC.



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⚠Caution

Continued from the preceding page. ↘

4-1. Reflow Soldering

1. When sudden heat is applied to the components, the mechanical strength of the components will decrease because a sudden temperature change causes deformation inside the components. In order to prevent mechanical damage to the components, preheating is required for both the components and the PCB. Preheating conditions are shown in table 1. It is required to keep the temperature differential between the solder and the components surface (ΔT) as small as possible.
2. When components are immersed in solvent after mounting, be sure to maintain the temperature difference (ΔT) between the component and the solvent within the range shown in table 1.

Table 1

Series	Chip Dimension Code (L/W)	Temperature Differential
GRM/GJM/GQM/GR3/GRJ/KRM/LLR/NFM/GR7	02/03/15/18/21/31	$\Delta T \leq 190^\circ\text{C}$
LLL	02/03/15/18/1U/21/31	
ZRB	15/18	
GR3/GRJ/GRM/KR3/KRM GA2/GA3/GR4	32/42/43/52/55	$\Delta T \leq 130^\circ\text{C}$
LLA/LLM	18/21/31	
GQM	22	

Recommended Conditions

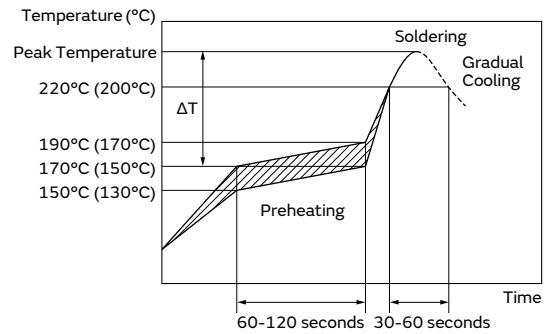
	Pb-Sn Solder	Lead Free Solder
Peak Temperature	230 to 250°C	240 to 260°C
Atmosphere	Air	Air or N ₂

Pb-Sn Solder: Sn-37Pb

Lead Free Solder: Sn-3.0Ag-0.5Cu

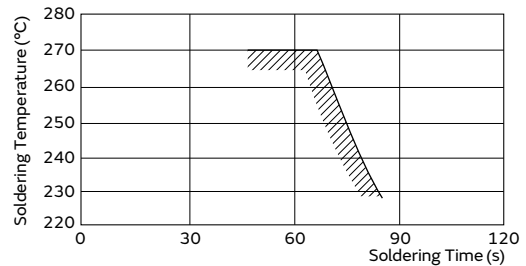
3. When a capacitor is mounted at a temperature lower than the peak reflow temperature recommended by the solder manufacturer, the following quality problems can occur. Consider factors such as the placement of peripheral components and the reflow temperature setting to prevent the capacitor's reflow temperature from dropping below the peak temperature specified. Be sure to evaluate the mounting situation beforehand and verify that none of the following problems occur.
 - Drop in solder wettability
 - Solder voids
 - Possible occurrence of whiskering
 - Drop in bonding strength
 - Drop in self-alignment properties
 - Possible occurrence of tombstones and/or shifting on the land patterns of the circuit board

[Example of Temperature Conditions for Reflow Soldering]



Temperature
 Incase of Lead Free Solder
 (): In case of Pb-Sn Solder

[Allowable Reflow Soldering Temperature and Time]



In the case of repeated soldering, the accumulated soldering time must be within the range shown above.

Continued on the following page. ↗

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
 GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 ⚠Caution

Caution

Continued from the preceding page. ↘

4. Optimum Solder Amount for Reflow Soldering

- 4-1. Overly thick application of solder paste results in a excessive solder fillet height.
 This makes the chip more susceptible to mechanical and thermal stress on the board and may cause the chips to crack.
- 4-2. Too little solder paste results in a lack of adhesive strength on the termination, which may result in chips breaking loose from the PCB.
- 4-3. Please confirm that solder has been applied smoothly to the termination.

<Applicable to NFM Series>

[Guideline of solder paste thickness]
 100-150 μ m: NFM15/18/21/3D/31
 100-200 μ m: NFM41

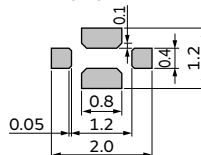
NFM15CC/15PC



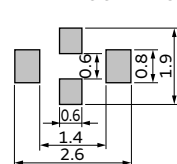
NFM18CC/18PC



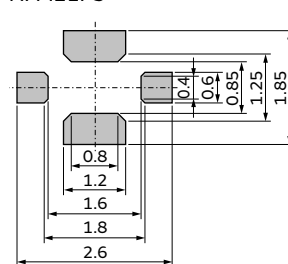
NFM18PS



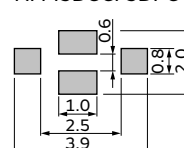
NFM21CC/21PC



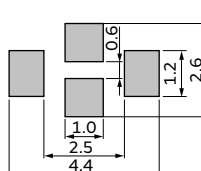
NFM21PS



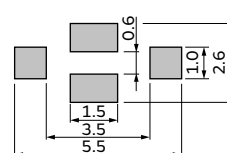
NFM3DCC/3DPC



NFM31PC/31KC



NFM41CC/41PC



Inverting the PCB

Make sure not to impose any abnormal mechanical shocks to the PCB.

Continued on the following page. ↗

- GRM
- GR3
- GRJ
- GR4
- GR7
- GJM
- GQM
- GA2
- GA3 GB
- GA3 GD
- GA3 GF
- LLL
- LLA
- LLM
- LLR
- NFM
- KRM
- KR3
- GMA
- GMD
- Caution

Caution

Continued from the preceding page. ↘

4-2. Flow Soldering

1. Do not apply flow soldering to chips not listed in table 2.

Table 2

Series	Chip Dimension Code (L/W)	Temperature Differential
GR3/GRM	18/21/31	$\Delta T \leq 150^{\circ}\text{C}$
GQM	18/21	
LLL	21/31	
GRJ	18/21/31	
NFM	3D/31/41	

- When sudden heat is applied to the components, the mechanical strength of the components will decrease because a sudden temperature change causes deformation inside the components. In order to prevent mechanical damage to the components, preheating is required for both of the components and the PCB. Preheating conditions are shown in table 2. It is required to keep the temperature differential between the solder and the components surface (ΔT) as low as possible.
- Excessively long soldering time or high soldering temperature can result in leaching of the terminations, causing poor adhesion or a reduction in capacitance value due to loss of contact between the inner electrodes and terminations.
- When components are immersed in solvent after mounting, be sure to maintain the temperature differential (ΔT) between the component and solvent within the range shown in the table 2.

Recommended Conditions

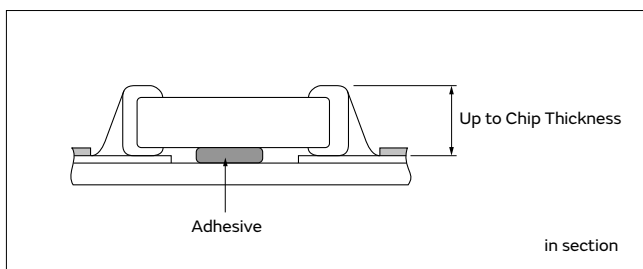
	Pb-Sn Solder	Lead Free Solder
Preheating Peak Temperature	90 to 110°C	100 to 120°C 140 to 160°C (NFM)
Soldering Peak Temperature	240 to 250°C	250 to 260°C
Atmosphere	Air	Air or N ₂

Pb-Sn Solder: Sn-37Pb

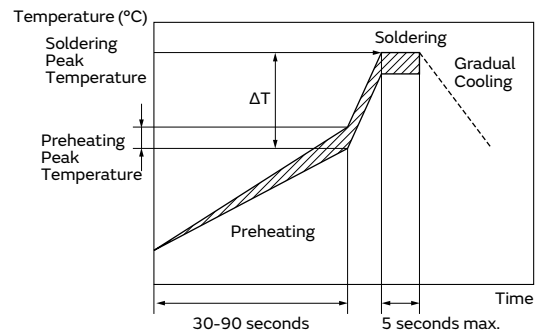
Lead Free Solder: Sn-3.0Ag-0.5Cu

5. Optimum Solder Amount for Flow Soldering

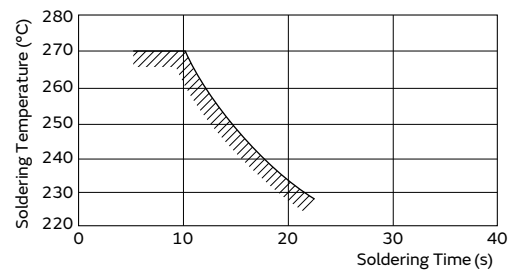
- The top of the solder fillet should be lower than the thickness of the components. If the solder amount is excessive, the risk of cracking is higher during board bending or any other stressful condition.



[Example of Temperature Conditions for Flow Soldering]



[Allowable Flow Soldering Temperature and Time]



In the case of repeated soldering, the accumulated soldering time must be within the range shown above.

Continued on the following page. ↗

- GRM
- GR3
- GRJ
- GR4
- GR7
- GJM
- GQM
- GA2
- GA3 GB
- GA3 GD
- GA3 GF
- LLL
- LLA
- LLM
- LLR
- NFM
- KRM
- KR3
- GMA
- GMD
- Caution

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
 GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 ⚠Caution

⚠Caution

Continued from the preceding page. ↘

4-3. Correction of Soldered Portion

When sudden heat is applied to the capacitor, distortion caused by the large temperature difference occurs internally, and can be the cause of cracks. Capacitors also tend to be affected by mechanical and thermal stress depending on the board preheating temperature or the soldering fillet shape, and can be the cause of cracks. Please refer to "1. PCB Design" or "3. Optimum solder amount" for the solder amount and the fillet shapes.

Do not correct with a soldering iron for ZRB series.
 Correction with a soldering iron for ZRB series may cause loss suppress acoustic noise, because the solder amount become excessive.

1. Correction with a Soldering Iron

- 1-1. In order to reduce damage to the capacitor, be sure to preheat the capacitor and the mounting board. Preheat to the temperature range shown in Table 3. A hot plate, hot air type preheater, etc. can be used for preheating.
- 1-2. After soldering, do not allow the component/PCB to cool down rapidly.
- 1-3. Perform the corrections with a soldering iron as quickly as possible. If the soldering iron is applied too long, there is a possibility of causing solder leaching on the terminal electrodes, which will cause deterioration of the adhesive strength and other problems.

Table 3

Series	Chip Dimension Code (L/W)	Temperature of Soldering Iron Tip	Preheating Temperature	Temperature Differential (ΔT)	Atmosphere
GJM/GQM/GR3/GRJ/GRM/GR7	03/15/18/21/31	350°C max.	150°C min.	$\Delta T \leq 190^\circ\text{C}$	Air
GRJ/GRM/GR4/GA2/GA3	32/42/43/52/55	280°C max.	150°C min.	$\Delta T \leq 130^\circ\text{C}$	Air
GQM	22				
NFM	3D/41	350°C max.	150°C min.	$\Delta T \leq 190^\circ\text{C}$	Air
	15	340°C max.			

*Applicable for both Pb-Sn and Lead Free Solder.
 Pb-Sn Solder: Sn-37Pb
 Lead Free Solder: Sn-3.0Ag-0.5Cu
 *Please manage ΔT in the temperature of soldering iron and the preheating temperature.

2. Correction with Spot Heater

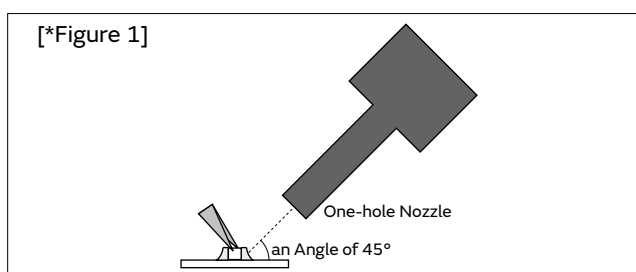
Compared to local heating with a soldering iron, hot air heating by a spot heater heats the overall component and board, therefore, it tends to lessen the thermal shock. In the case of a high density mounted board, a spot heater can also prevent concerns of the soldering iron making direct contact with the component.

2-1. If the distance from the hot air outlet of the spot heater to the component is too close, cracks may occur due to thermal shock. To prevent this problem, follow the conditions shown in Table 4.

2-2. In order to create an appropriate solder fillet shape, it is recommended that hot air be applied at the angle shown in Figure 1.

Table 4

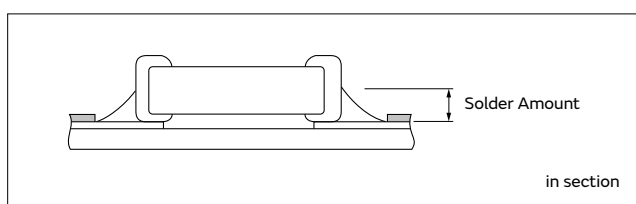
Distance	5mm or more
Hot Air Application Angle	45° *Figure 1
Hot Air Temperature Nozzle Outlet	400°C max.
Application Time	Less than 10 seconds (1206 (3216M) size or smaller)
	Less than 30 seconds (1210 (3225M) size or larger)



3. Optimum solder amount when re-working with a soldering iron

3-1. If the solder amount is excessive, the risk of cracking is higher during board bending or any other stressful condition.
 Too little solder amount results in a lack of adhesive strength on the termination, which may result in chips breaking loose from the PCB.

Please confirm that solder has been applied smoothly and rising to the end surface of the chip.



Continued on the following page. ↗

Caution

Continued from the preceding page. ↘

- 3-2. A soldering iron with a tip of $\varnothing 3\text{mm}$ or smaller should be used. It is also necessary to keep the soldering iron from touching the components during the re-work.
- 3-3. Solder wire with $\varnothing 0.5\text{mm}$ or smaller is required for soldering.

<Applicable to KR3/KRM Series>

4. For the shape of the soldering iron tip, refer to the figure on the right.

Regarding the type of solder, use a wire diameter of $\varnothing 0.5\text{mm}$ or less (rosin core wire solder).

4-1. How to Apply the Soldering Iron

Apply the tip of the soldering iron against the lower end of the metal terminal.

- 1) In order to prevent cracking caused by sudden heating of the ceramic device, do not touch the ceramic base directly.
- 2) In order to prevent deviations and dislocating of the chip, do not touch the junction of the chip and the metal terminal, and the metal portion on the outside directly.

4-2. Appropriate Amount of Solder

The amount of solder for corrections by soldering iron, should be lower than the height of the lower side of the chip.



5. Washing

Excessive ultrasonic oscillation during cleaning can cause the PCBs to resonate, resulting in cracked chips or broken solder joints. Before starting your production process, test your cleaning equipment/process to insure it does not degrade the capacitors.

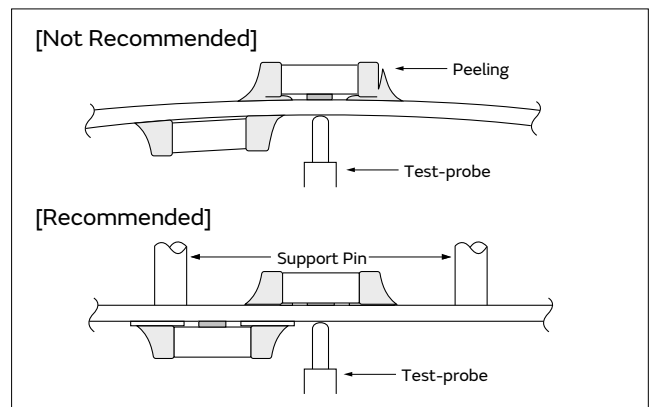
6. Electrical Test on Printed Circuit Board

1. Confirm position of the support pin or specific jig, when inspecting the electrical performance of a capacitor after mounting on the printed circuit board.

1-1. Avoid bending the printed circuit board by the pressure of a test-probe, etc.

The thrusting force of the test probe can flex the PCB, resulting in cracked chips or open solder joints. Provide support pins on the back side of the PCB to prevent warping or flexing. Install support pins as close to the test-probe as possible.

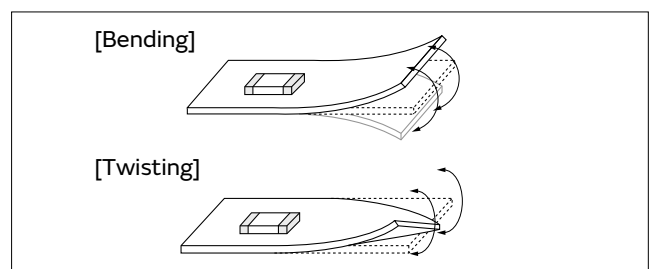
1-2. Avoid vibration of the board by shock when a test-probe contacts a printed circuit board.



7. Printed Circuit Board Cropping

1. After mounting a capacitor on a printed circuit board, do not apply any stress to the capacitor that causes bending or twisting the board.

- 1-1. In cropping the board, the stress as shown at right may cause the capacitor to crack. Cracked capacitors may cause deterioration of the insulation resistance, and result in a short. Avoid this type of stress to a capacitor.



Continued on the following page. ↗

Caution

Continued from the preceding page. ↘

2. Check the cropping method for the printed circuit board in advance.

2-1. Printed circuit board cropping shall be carried out by using a jig or an apparatus (Disc separator, router type separator, etc.) to prevent the mechanical stress that can occur to the board.

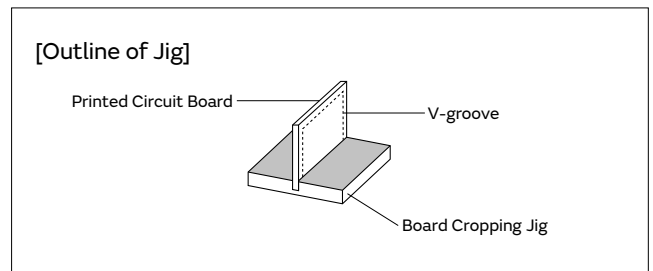
Board Separation Method	Hand Separation Nipper Separation	(1) Board Separation Jig	Board Separation Apparatus	
			(2) Disc Separator	(3) Router Type Separator
Level of stress on board	High	Medium	Medium	Low
Recommended	×	△*	△*	○
Notes	Hand and nipper separation apply a high level of stress. Use another method.	<ul style="list-style-type: none"> Board handling Board bending direction Layout of capacitors 	<ul style="list-style-type: none"> Board handling Layout of slits Design of V groove Arrangement of blades Controlling blade life 	Board handling

* When a board separation jig or disc separator is used, if the following precautions are not observed, a large board deflection stress will occur and the capacitors may crack. Use router type separator if at all possible.

(1) Example of a suitable jig

[In the case of Single-side Mounting]

An outline of the board separation jig is shown as follows. Recommended example: Stress on the component mounting position can be minimized by holding the portion close to the jig, and bend in the direction towards the side where the capacitors are mounted. Not recommended example: The risk of cracks occurring in the capacitors increases due to large stress being applied to the component mounting position, if the portion away from the jig is held and bent in the direction opposite the side where the capacitors are mounted.



Hand Separation

Recommended	Not Recommended

[In the case of Double-sided Mounting]

Since components are mounted on both sides of the board, the risk of cracks occurring can not be avoided with the above method. Therefore, implement the following measures to prevent stress from being applied to the components.

(Measures)

- (1) Consider introducing a router type separator. If it is difficult to introduce a router type separator, implement the following measures. (Refer to item 1. Mounting Position)
- (2) Mount the components parallel to the board separation surface.
- (3) When mounting components near the board separation point, add slits in the separation position near the component.
- (4) Keep the mounting position of the components away from the board separation point.

Continued on the following page. ↗

GRM
GR3
GRJ
GR4
GR7
GJM
GQM
GA2
GA3 GB
GA3 GD
GA3 GF
LLL
LLA
LLM
LLR
NFM
KRM
KR3
GMA
GMD
Caution

⚠Caution

Continued from the preceding page. ↘

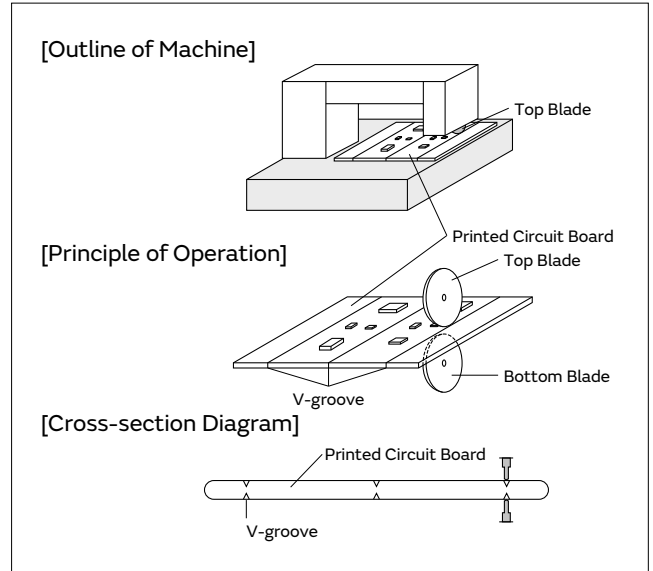
(2) Example of a Disc Separator

An outline of a disc separator is shown as follows. As shown in the Principle of Operation, the top blade and bottom blade are aligned with the V-grooves on the printed circuit board to separate the board.

In the following case, board deflection stress will be applied and cause cracks in the capacitors.

- (1) When the adjustment of the top and bottom blades are misaligned, such as deviating in the top-bottom, left-right or front-rear directions
- (2) The angle of the V groove is too low, depth of the V groove is too shallow, or the V groove is misaligned top-bottom

IF V groove is too deep, it is possible to brake when you handle and carry it. Carefully design depth of the V groove with consideration about strength of material of the printed circuit board.



Disc Separator

Recommended	Not Recommended		
	Top-bottom Misalignment	Left-right Misalignment	Front-rear Misalignment
<p>Top Blade</p> <p>Bottom Blade</p>	<p>Top Blade</p> <p>Bottom Blade</p>	<p>Top Blade</p> <p>Bottom Blade</p>	<p>Top Blade</p> <p>Bottom Blade</p>

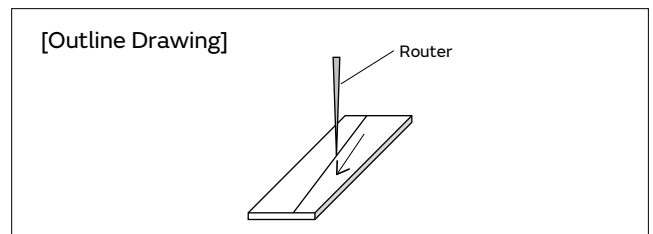
V-groove Design

Example of Recommended V-groove Design	Not Recommended			
	Left-right Misalignment	Low-Angle	Depth too Shallow	Depth too Deep

(3) Example of Router Type Separator

The router type separator performs cutting by a router rotating at a high speed. Since the board does not bend in the cutting process, stress on the board can be suppressed during board separation.

When attaching or removing boards to/from the router type separator, carefully handle the boards to prevent bending.



Continued on the following page. ↗

GRM
GR3
GRJ
GR4
GR7
GJM
GQM
GA2
GA3 GB
GA3 GD
GA3 GF
LLL
LLA
LLM
LLR
NFM
KRM
KR3
GMA
GMD
Caution

⚠Caution

Continued from the preceding page. ↘

8. Assembly

1. Handling

If a board mounted with capacitors is held with one hand, the board may bend. Firmly hold the edges of the board with both hands when handling.

If a board mounted with capacitors is dropped, cracks may occur in the capacitors.

Do not use dropped boards, as there is a possibility that the quality of the capacitors may be impaired.

2. Attachment of Other Components

2-1. Mounting of Other Components

Pay attention to the following items, when mounting other components on the back side of the board after capacitors have been mounted on the opposite side.

When the bottom dead point of the suction nozzle is set too low, board deflection stress may be applied to the capacitors on the back side (bottom side), and cracks may occur in the capacitors.

- After the board is straightened, set the bottom dead point of the nozzle on the upper surface of the board.
- Periodically check and adjust the bottom dead point.

2-2. Inserting Components with Leads into Boards

When inserting components (transformers, IC, etc.) into boards, bending the board may cause cracks in the capacitors or cracks in the solder.

Pay attention to the following.

- Increase the size of the holes to insert the leads, to reduce the stress on the board during insertion.
- Fix the board with support pins or a dedicated jig before insertion.
- Support below the board so that the board does not bend. When using support pins on the board, periodically confirm that there is no difference in the height of each support pin.

2-3. Attaching/Removing Sockets and/or Connectors

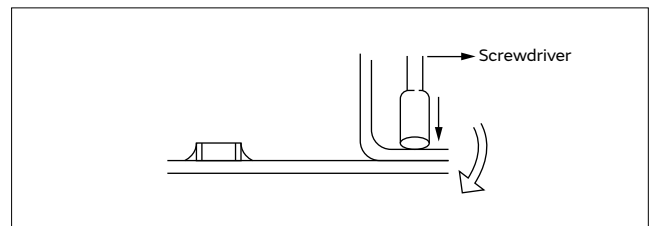
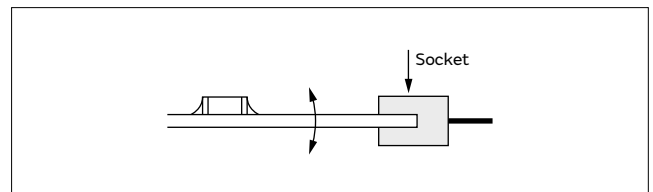
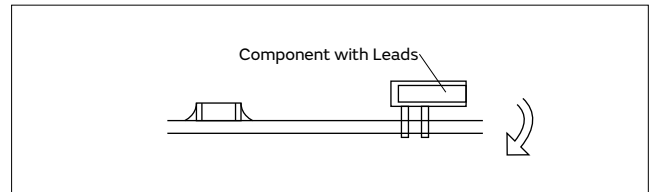
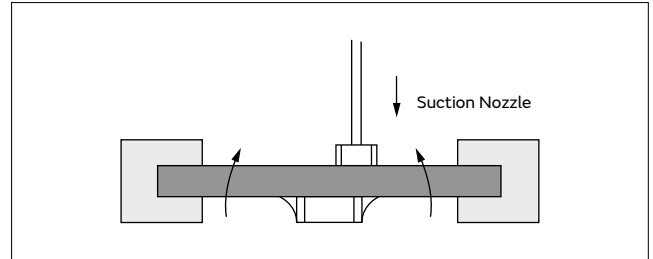
Insertion and removal of sockets and connectors, etc., might cause the board to bend. Please insure that the board does not warp during insertion and removal of sockets and connectors, etc., or the bending may damage mounted components on the board.

2-4. Tightening Screws

The board may be bent, when tightening screws, etc. during the attachment of the board to a shield or chassis.

Pay attention to the following items before performing the work.

- Plan the work to prevent the board from bending.
- Use a torque screwdriver, to prevent over-tightening of the screws.
- The board may bend after mounting by reflow soldering, etc. Please note, as stress may be applied to the chips by forcibly flattening the board when tightening the screws.



⚠Caution

Continued from the preceding page. ↘

<Applicable to GMA or GMD Series>

9. Die Bonding/Wire Bonding

1. Die Bonding of Capacitors

1-1. Use the following materials for the Brazing alloys:
Au-Sn (80/20) 300 to 320 °C in N₂ atmosphere

1-2. Mounting

- (1) Control the temperature of the substrate so it matches the temperature of the brazing alloy.
- (2) Place the brazing alloy on the substrate and place the capacitor on the alloy. Hold the capacitor and gently apply the load. Be sure to complete the operation within 1 minute.

2. Wire Bonding

2-1. Wire

Gold wire: 25 micro m (0.001 inch) diameter

2-2. Bonding

- (1) Thermo compression, ultrasonic ball bonding.
- (2) Required stage temperature: 150 to 200 °C
- (3) Required wedge or capillary weight: 0.2N to 0.5N
- (4) Bond the capacitor and base substrate or other devices with gold wire.

Other

1. Under Operation of Equipment

- 1-1. Do not touch a capacitor directly with bare hands during operation in order to avoid the danger of an electric shock.
- 1-2. Do not allow the terminals of a capacitor to come in contact with any conductive objects (short-circuit). Do not expose a capacitor to a conductive liquid, including any acid or alkali solutions.
- 1-3. Confirm the environment in which the equipment will operate is under the specified conditions. Do not use the equipment under the following environments.
 - (1) Being splattered with water or oil.
 - (2) Being exposed to direct sunlight.
 - (3) Being exposed to ozone, ultraviolet rays, or radiation.
 - (4) Being exposed to toxic gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas, etc.)
 - (5) Any vibrations or mechanical shocks exceeding the specified limits.
 - (6) Moisture condensing environments.
- 1-4. Use damp proof countermeasures if using under any conditions that can cause condensation.

Continued on the following page. ↗

GRM

GR3

GRJ

GR4

GR7

GJM

GQM

GA2

GA3
GB

GA3
GD

GA3
GF

LLL

LLA

LLM

LLR

NFM

KRM

KR3

GMA

GMD

⚠Caution

281

⚠Caution

Continued from the preceding page. ↘

2. Other

2-1. In an Emergency

- (1) If the equipment should generate smoke, fire, or smell, immediately turn off or unplug the equipment.

If the equipment is not turned off or unplugged, the hazards may be worsened by supplying continuous power.

- (2) In this type of situation, do not allow face and hands to come in contact with the capacitor or burns may be caused by the capacitor's high temperature.

2-2. Disposal of Waste

When capacitors are disposed of, they must be burned or buried by an industrial waste vendor with the appropriate licenses.

2-3. Circuit Design

(1) Addition of Fail Safe Function

Capacitors that are cracked by dropping or bending of the board may cause deterioration of the insulation resistance, and result in a short.

If the circuit being used may cause an electrical shock, smoke or fire when a capacitor is shorted, be sure to install fail-safe functions, such as a fuse, to prevent secondary accidents.

- (2) Capacitors used to prevent electromagnetic interference in the primary AC side circuit, or as a connection/insulation, must be a safety standard certified product, or satisfy the contents stipulated in the Electrical Appliance and Material Safety Law. Install a fuse for each line in case of a short.

- (3) The GJM, GMA, GMD, GQM, GR3, GRJ, GRM, KR3, KRM, LLA, LLL, LLM, LLR, NFM and ZRB series are not safety standard certified products.

2-4. Test Condition for AC Withstanding Voltage

(1) Test Equipment

Test equipment for AC withstanding voltage should be made with equipment capable of creating a wave similar to a 50/60Hz sine wave.

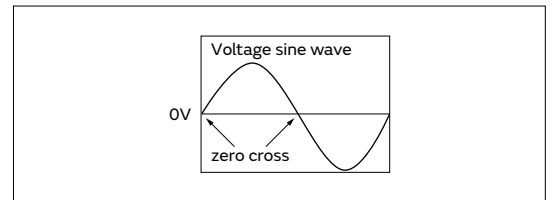
(2) Voltage Applied Method

The capacitor's lead or terminal should be firmly connected to the output of the withstanding voltage test equipment, and then the voltage should be raised from near zero to the test voltage.

If the test voltage is applied directly to the capacitor without raising it from near zero, it should be applied with the zero cross. *At the end of the test time, the test voltage should be reduced to near zero, and then capacitor's lead or terminals should be taken off the output of the withstanding voltage test equipment.

If the test voltage applied directly to the capacitor without raising it from near zero, surge voltage may occur and cause a defect.

*ZERO CROSS is the point where voltage sine wave passes 0V. - See the figure at right -



2-5. Remarks

Failure to follow the cautions may result, worst case, in a short circuit and smoking when the product is used.

The above notices are for standard applications and conditions. Contact us when the products are used in special mounting conditions.

Select optimum conditions for operation as they determine the reliability of the product after assembly.

The data herein are given in typical values, not guaranteed ratings.

GRM

GR3

GRJ

GR4

GR7

GJM

GQM

GA2

GA3

GB

GA3

GD

GA3

GF

LLL

LLA

LLM

LLR

NFM

KRM

KR3

GMA

GMD

⚠Caution

Notice

Rating

1. Operating Temperature

1. The operating temperature limit depends on the capacitor.
 - 1-1. Do not apply temperatures exceeding the maximum operating temperature.
It is necessary to select a capacitor with a suitable rated temperature that will cover the operating temperature range.
It is also necessary to consider the temperature distribution in equipment and the seasonal temperature variable factor.
 - 1-2. Consider the self-heating factor of the capacitor.
The surface temperature of the capacitor shall not exceed the maximum operating temperature including self-heating.

2. Atmosphere Surroundings (gaseous and liquid)

1. Restriction on the operating environment of capacitors.
 - 1-1. Capacitors, when used in the above, unsuitable, operating environments may deteriorate due to the corrosion of the terminations and the penetration of moisture into the capacitor.
 - 1-2. The same phenomenon as the above may occur when the electrodes or terminals of the capacitor are subject to moisture condensation.
 - 1-3. The deterioration of characteristics and insulation resistance due to the oxidization or corrosion of terminal electrodes may result in breakdown when the capacitor is exposed to corrosive or volatile gases or solvents for long periods of time.

Soldering and Mounting

1. PCB Design

1. Notice for Pattern Forms
 - 1-1. Unlike leaded components, chip components are susceptible to flexing stresses since they are mounted directly on the substrate.
They are also more sensitive to mechanical and thermal stresses than leaded components.
Excess solder fillet height can multiply these stresses and cause chip cracking. When designing substrates, take land patterns and dimensions into consideration to eliminate the possibility of excess solder fillet height.
 - 1-2. There is a possibility of chip cracking caused by PCB expansion/contraction with heat, because stress on a chip is different depending on PCB material and structure. When the thermal expansion coefficient greatly differs between the board used for mounting and the chip, it will cause cracking of the chip due to the thermal expansion and contraction.
When capacitors are mounted on a fluorine resin printed circuit board or on a single-layered glass epoxy board, it may also cause cracking of the chip for the same reason.

3. Piezo-electric Phenomenon

1. When using high dielectric constant type capacitors in AC or pulse circuits, the capacitor itself vibrates at specific frequencies and noise may be generated.
Moreover, when the mechanical vibration or shock is added to the capacitor, noise may occur.

<Applicable to NFM Series>

- 1-3. Because noise is suppressed by shunting unwanted high-frequency components to the ground, when designing a land for the NFM series, design the ground pattern to be as large as possible in order to better bring out this characteristic.
As shown in the figure below, noise countermeasures can be made more effective by using a via to connect the ground pattern on the chip mounting surface to a larger ground pattern on the inner layer.

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Notice

Continued from the preceding page. ↘

Pattern Forms

	Prohibited	Correct
Placing Close to Chassis	<p>Chassis Solder (ground) Electrode Pattern</p> <p>in section</p>	<p>Solder Resist</p> <p>in section</p>
Placing of Chip Components and Leaded Components	<p>Lead Wire</p> <p>in section</p>	<p>Solder Resist</p> <p>in section</p>
Placing of Leaded Components after Chip Component	<p>Soldering Iron Lead Wire</p> <p>in section</p>	<p>Solder Resist</p> <p>in section</p>
Lateral Mounting		<p>Solder Resist</p>

2. Land Dimensions

2-1. Please refer to the land dimensions in table 1 for flow soldering, table 2 for reflow soldering, table 3 for reflow soldering for ZRB Series, table 4 for reflow soldering for LLA Series, table 5 for reflow soldering for LLM Series.

Please confirm the suitable land dimension by evaluating of the actual SET / PCB.

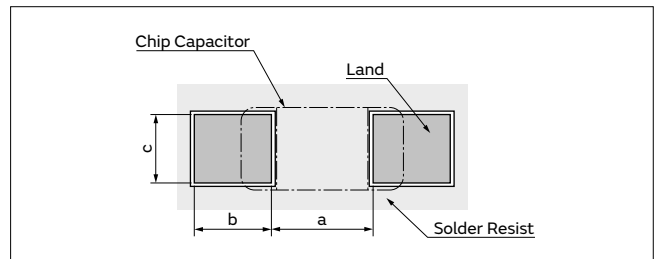


Table 1 Flow Soldering Method

Series	Chip Dimension Code (L/W)	Chip (L×W)	a	b	c
GQM/GR3/GRJ/GRM	18	1.6×0.8	0.6 to 1.0	0.8 to 0.9	0.6 to 0.8
GQM/GR3/GRJ/GRM	21	2.0×1.25	1.0 to 1.2	0.9 to 1.0	0.8 to 1.1
GR3/GRJ/GRM	31	3.2×1.6	2.2 to 2.6	1.0 to 1.1	1.0 to 1.4
LLL	21	1.25×2.0	0.4 to 0.7	0.5 to 0.7	1.4 to 1.8
LLL	31	1.6×3.2	0.6 to 1.0	0.8 to 0.9	2.6 to 2.8

Flow soldering can only be used for products with a chip size from 1.6x0.8mm to 3.2x1.6mm.

(in mm)

Continued on the following page. ↗

Notice

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Table 2 Reflow Soldering Method

Series	Chip Dimension Code (L/W)	Chip (L×W)	a	b	c
GJM/GRM	02	0.4×0.2	0.16 to 0.2	0.12 to 0.18	0.2 to 0.23
GJM/GRM	03	0.6×0.3 (±0.03)	0.2 to 0.25	0.2 to 0.3	0.25 to 0.35
		0.6×0.3 (±0.05)	0.2 to 0.25	0.25 to 0.35	0.3 to 0.4
		0.6×0.3 (±0.09)	0.23 to 0.3	0.25 to 0.35	0.3 to 0.4
GJM/GRM	15	1.0×0.5 (within ±0.10)	0.3 to 0.5	0.35 to 0.45	0.4 to 0.6
		1.0×0.5 (±0.15/±0.20)	0.4 to 0.6	0.4 to 0.5	0.5 to 0.7
GQM/GR3/GRJ/GRM	18	1.6×0.8 (within ±0.10)	0.6 to 0.8	0.6 to 0.7	0.6 to 0.8
		1.6×0.8 (±0.15/±0.20)	0.7 to 0.9	0.7 to 0.8	0.8 to 1.0
GQM	21	2.0×1.25	1.0 to 1.2	0.6 to 0.7	0.8 to 1.1
GR3/GRJ/GRM/GR7	21	2.0×1.25 (within ±0.10)	1.2	0.6	1.25
		2.0×1.25 (±0.15)	1.2	0.6 to 0.8	1.2 to 1.4
		2.0×1.25 (±0.20)	1.0 to 1.4	0.6 to 0.8	1.2 to 1.4
GQM	22	2.8×2.8	2.2 to 2.5	0.8 to 1.0	1.9 to 2.3
GR3/GRJ/GRM/GR7	31	3.2×1.6 (within ±0.20)	1.8 to 2.0	0.9 to 1.2	1.5 to 1.7
		3.2×1.6 (±0.30)	1.9 to 2.1	1.0 to 1.3	1.7 to 1.9
GR3/GRJ/GRM	32	3.2×2.5	2.0 to 2.4	1.0 to 1.2	1.8 to 2.3
GA2/GA3/GR4	42	4.5×2.0	2.8 to 3.4	1.2 to 1.4	1.4 to 1.8
GR3/GRJ/GRM/GA2/GA3/GR4	43	4.5×3.2	3.0 to 3.5	1.2 to 1.4	2.3 to 3.0
GA2/GA3	52	5.7×2.8	4.0 to 4.6	1.4 to 1.6	2.1 to 2.6
GR3/GRJ/GRM/GA2/GA3/GR4	55	5.7×5.0	4.0 to 4.6	1.4 to 1.6	3.5 to 4.8
LLL	15	0.5×1.0	0.15 to 0.2	0.2 to 0.25	0.7 to 1.0
LLL	1U	0.6×1.0	0.20 to 0.25	0.25 to 0.35	0.7 to 1.0
LLL/LLR	18	0.8×1.6	0.2 to 0.3	0.3 to 0.4	1.4 to 1.6
LLL	21	1.25×2.0	0.4 to 0.5	0.4 to 0.5	1.4 to 1.8
LLL	31	1.6×3.2	0.6 to 0.8	0.6 to 0.7	2.6 to 2.8

(in mm)

<Applicable to Part Number KR3/KRM>

Series	Chip Dimension Code (L/W)	Chip (L×W)	a	b	c
KRM	21	2.0×1.25	1.0 to 1.2	0.6 to 0.7	0.8 to 1.1
KRM	31	3.2×1.6	2.2 to 2.4	0.8 to 0.9	1.0 to 1.4
KR3/KRM	55	5.7×5.0	2.6	2.7	5.6

(in mm)

Table 3 ZRB Series Reflow Soldering Method

Series	Chip Dimension Code (L/W)	Chip (L×W)	a	b	c
ZRB	15	1.0×0.5	0.4 to 0.6	0.4 to 0.5	0.5 to 0.7
ZRB	18*	1.6×0.8	0.7 to 0.9	0.7 to 0.8	0.8 to 1.0

*If distance between parts is too short, there is risk to cause electrical short. Please confirm the mounting pitch (distance between centers of parts) has 1.275mm or more. (ZRB18 only)

[Land for ZRB Series]

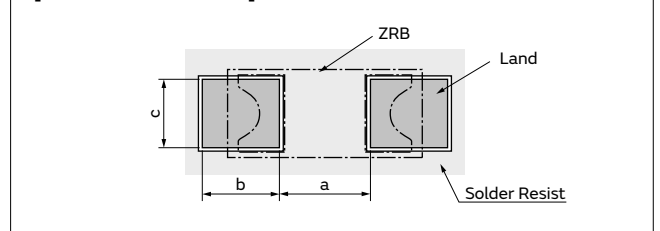


Table 4 LLA Series Reflow Soldering Method

Series	Chip Dimension Code (L/W)	Chip (L×W)	a	b	c	p
LLA	18	1.6×0.8	0.3 to 0.4	0.25 to 0.35	0.15 to 0.25	0.4
LLA	21	2.0×1.25	0.5 to 0.7	0.35 to 0.6	0.2 to 0.3	0.5

(in mm)

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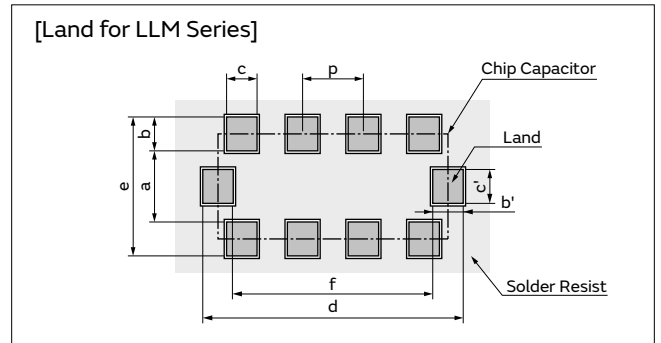
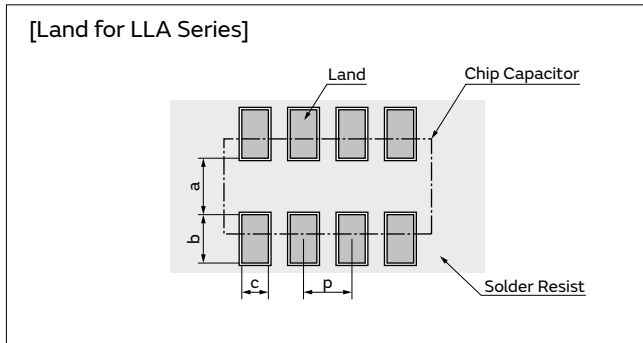
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Table 5 LLM Series Reflow Soldering Method

Series	Chip Dimension Code (L/W)	Chip (L×W)	a	b, b'	c, c'	d	e	f	p
LLM	21	2.0×1.25	0.6 to 0.8	(0.3 to 0.5)	0.3	2.0 to 2.6	1.3 to 1.8	1.4 to 1.6	0.5

$b=(c-e)/2, b'=(d-f)/2$ (in mm)



<Applicable to beyond Rated Voltage of 200VDC>

2-2. Dimensions of Slit (Example)

Preparing the slit helps flux cleaning and resin coating on the back of the capacitor.

However, the length of the slit design should be as short as possible to prevent mechanical damage in the capacitor.

A longer slit design might receive more severe mechanical stress from the PCB.

Recommended slit design is shown in the Table.

The diagram shows a side view of a chip capacitor with a slit. The slit is a narrow gap in the top surface of the capacitor. The solder resist is a layer on the bottom surface. Dimensions are labeled: 'L' is the length of the capacitor; 'W' is the width of the capacitor; 'd' is the width of the slit; 'e' is the depth of the slit. Labels include 'Chip Capacitor', 'Slit', 'Solder Resist', and 'Land'.

L×W	d	e
1.6×0.8	-	-
2.0×1.25	-	-
3.2×1.6	1.0 to 2.0	3.2 to 3.7
3.2×2.5	1.0 to 2.0	4.1 to 4.6
4.5×2.0	1.0 to 2.8	3.6 to 4.1
4.5×3.2	1.0 to 2.8	4.8 to 5.3
5.7×2.8	1.0 to 4.0	4.4 to 4.9
5.7×5.0	1.0 to 4.0	6.6 to 7.1

(in mm)

Continued on the following page. ↗

GRM
 GR3
 GRJ
 GR4
 GR7
 GJM
 GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
 Notice

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<Applicable to NFM Series>

Land Pattern + Solder Resist
 Land Pattern
 Solder Resist
 (in mm)

Series	Land Dimensions																																																									
NFM15CC NFM15PC NFM18CC NFM18PC NFM18PS NFM21CC NFM21PC NFM21PS	● Reflow Soldering																																																									
	NFM15CC/NFM15PC	NFM18CC/NFM18PC	NFM18PS																																																							
	NFM21CC/NFM21PC Small diameter thru hole $\phi 0.4$	NFM21PS Small diameter thru hole $\phi 0.2-\phi 0.3$																																																								
	● Reflow Soldering Chip mounting side																																																									
NFM3DCC NFM3DPC NFM31PC NFM31KC NFM41CC NFM41PC	NFM3DCC/NFM3DPC/NFM31PC/NFM41CC/NFM41PC Small diameter thru hole $\phi 0.4$																																																									
		<table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th rowspan="2">Part Number</th> <th colspan="7">Size (mm)</th> </tr> <tr> <th>a</th> <th>b</th> <th>c</th> <th>d</th> <th>e</th> <th>f</th> <th>g</th> </tr> </thead> <tbody> <tr> <td>NFM3DCC</td> <td>1.0</td> <td>1.4</td> <td>2.5</td> <td>4.4</td> <td>1.0</td> <td>2.0</td> <td>2.4</td> </tr> <tr> <td>NFM3DPC</td> <td>1.0</td> <td>1.4</td> <td>2.5</td> <td>4.4</td> <td>1.0</td> <td>2.0</td> <td>2.4</td> </tr> <tr> <td>NFM31PC</td> <td>1.0</td> <td>1.4</td> <td>2.5</td> <td>4.4</td> <td>1.2</td> <td>2.6</td> <td>3.0</td> </tr> <tr> <td>NFM41CC</td> <td>1.5</td> <td>2.0</td> <td>3.5</td> <td>6.0</td> <td>1.2</td> <td>2.6</td> <td>3.0</td> </tr> <tr> <td>NFM41PC</td> <td>1.5</td> <td>2.0</td> <td>3.5</td> <td>6.0</td> <td>1.2</td> <td>2.6</td> <td>3.0</td> </tr> </tbody> </table>		Part Number	Size (mm)							a	b	c	d	e	f	g	NFM3DCC	1.0	1.4	2.5	4.4	1.0	2.0	2.4	NFM3DPC	1.0	1.4	2.5	4.4	1.0	2.0	2.4	NFM31PC	1.0	1.4	2.5	4.4	1.2	2.6	3.0	NFM41CC	1.5	2.0	3.5	6.0	1.2	2.6	3.0	NFM41PC	1.5	2.0	3.5	6.0	1.2	2.6	3.0
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GRM
 GR3
 GRJ
 GRU
 GR4
 GR7
 GJM
 GQM
 GA2
 GA3 GB
 GA3 GD
 GA3 GF
 LLL
 LLA
 LLM
 LLR
 NFM
 KRM
 KR3
 GMA
 GMD
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3. Board Design

When designing the board, keep in mind that the amount of strain which occurs will increase depending on the size and material of the board.

[Relationship with amount of strain to the board thickness, length, width, etc.]

$$\epsilon = \frac{3PL}{2Ewh^2}$$

Relationship between load and strain

ϵ : Strain on center of board (μst)
 L : Distance between supporting points (mm)
 w : Board width (mm)
 h : Board thickness (mm)
 E : Elastic modulus of board ($\text{N}/\text{m}^2=\text{Pa}$)
 Y : Deflection (mm)
 P : Load (N)



When the load is constant, the following relationship can be established.

- As the distance between the supporting points (L) increases, the amount of strain also increases.
 →Reduce the distance between the supporting points.
 - As the elastic modulus (E) decreases, the amount of strain increases.
 →Increase the elastic modulus.
 - As the board width (w) decreases, the amount of strain increases.
 →Increase the width of the board.
 - As the board thickness (h) decreases, the amount of strain increases.
 →Increase the thickness of the board.
- Since the board thickness is squared, the effect on the amount of strain becomes even greater.

2. Adhesive Application

If you want to temporarily attach the capacitor to the board using an adhesive agent before soldering the capacitor, first be sure that the conditions are appropriate for affixing the capacitor. If the dimensions of the land, the type of adhesive, the amount of coating, the contact surface area, the curing temperature, or other conditions are inappropriate, the characteristics of the capacitor may deteriorate.

1. Selection of Adhesive

1-1. Depending on the type of adhesive, there may be a decrease in insulation resistance. In addition, there is a chance that the capacitor might crack from contractile stress due to the difference in the contraction rate of the capacitor and the adhesive.

1-2. If there is not enough adhesive, the contact surface area is too small, or the curing temperature or curing time are inadequate, the adhesive strength will be insufficient and the capacitor may loosen or become disconnected during transportation or soldering.

If there is too much adhesive, for example if it overflows onto the land, the result could be soldering defects, loss of electrical connection, insufficient curing, or slippage after the capacitor is mounted.

Furthermore, if the curing temperature is too high or the curing time is too long, not only will the adhesive

strength be reduced, but solderability may also suffer due to the effects of oxidation on the terminations (outer electrodes) of the capacitor and the land surface on the board.

(1) Selection of Adhesive

Epoxy resins are a typical class of adhesive.

To select the proper adhesive, consider the following points.

- 1) There must be enough adhesive strength to prevent the component from loosening or slipping during the mounting process.
- 2) The adhesive strength must not decrease when exposed to moisture during soldering.
- 3) The adhesive must have good coatability and shape retention properties.
- 4) The adhesive must have a long pot life.
- 5) The curing time must be short.
- 6) The adhesive must not be corrosive to the exterior of the capacitor or the board.
- 7) The adhesive must have good insulation properties.
- 8) The adhesive must not emit toxic gases or otherwise be harmful to health.
- 9) The adhesive must be free of halogenated compounds.

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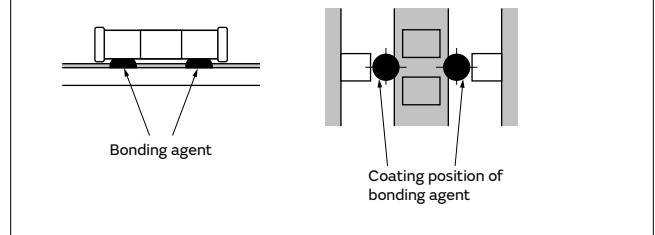
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(2) Use the following illustration as a guide to the amount of adhesive to apply.



<Applicable to NFM Series>

[Sizes: 1205(3212M) / 1206(3216M) / 1806(4516M)]



3. Adhesive Curing

1. Insufficient curing of the adhesive can cause chips to disconnect during flow soldering and causes deterioration in the insulation resistance between the terminations due to moisture absorption.

Control curing temperature and time in order to prevent insufficient hardening.

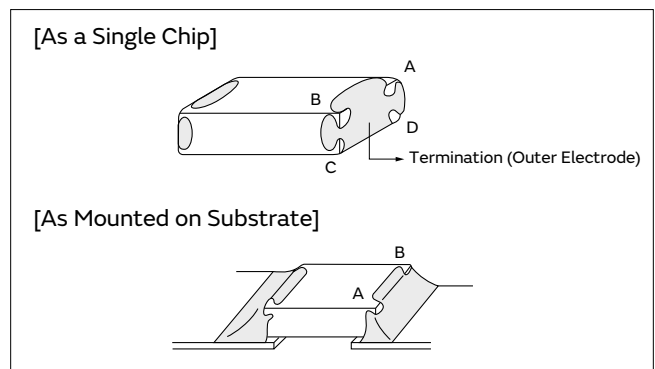
4. Flux for Flow Soldering

1. An excessive amount of flux generates a large quantity of flux gas, which can cause a deterioration of solderability, so apply flux thinly and evenly throughout. (A foaming system is generally used for flow soldering.)

2. Flux containing too high a percentage of halide may cause corrosion of the terminations unless there is sufficient cleaning. Use flux with a halide content of 0.1% max.
 3. Strong acidic flux can corrode the capacitor and degrade its performance.
 Please check the quality of capacitor after mounting.

5. Flow Soldering

● Set temperature and time to ensure that leaching of the terminations does not exceed 25% of the chip end area as a single chip (full length of the edge A-B-C-D shown at right) and 25% of the length A-B shown as mounted on substrate.



6. Reflow Soldering

The flux in the solder paste contains halogen-based substances and organic acids as activators. Strong acidic flux can corrode the capacitor and degrade its performance.

Please check the quality after mounting, please use.

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7. Washing

1. Please evaluate the capacitor using actual cleaning equipment and conditions to confirm the quality, and select the solvent for cleaning.

8. Coating

1. A crack may be caused in the capacitor due to the stress of the thermal contraction of the resin during curing process.
The stress is affected by the amount of resin and curing contraction.
Select a resin with low curing contraction.
The difference in the thermal expansion coefficient between a coating resin or a molding resin and the capacitor may cause the destruction and deterioration of the capacitor such as a crack or peeling, and lead to the deterioration of insulation resistance or dielectric breakdown.
Select a resin for which the thermal expansion coefficient is as close to that of the capacitor as possible.
A silicone resin can be used as an under-coating to buffer against the stress.

2. Unsuitable cleaning may leave residual flux or other foreign substances, causing deterioration of electrical characteristics and the reliability of the capacitors.

2. Select a resin that is less hygroscopic.
Using hygroscopic resins under high humidity conditions may cause the deterioration of the insulation resistance of a capacitor.
An epoxy resin can be used as a less hygroscopic resin.
3. The halogen system substance and organic acid are included in coating material, and a chip corrodes by the kind of Coating material.
Do not use strong acid type.

<Applicable to ZRB Series>

4. Loss suppress acoustic noise may be caused in ZRB series due to the resin during curing process. Please contact our sales representative or product engineers on the apply to resin during curing process.

Other

1. Transportation

1. The performance of a capacitor may be affected by the conditions during transportation.
 - 1-1. The capacitors shall be protected against excessive temperature, humidity, and mechanical force during transportation.
 - (1) Climatic condition
 - low air temperature: -40°C
 - change of temperature air/air: -25°C/+25°C
 - low air pressure: 30 kPa
 - change of air pressure: 6 kPa/min.
 - (2) Mechanical condition
Transportation shall be done in such a way that the boxes are not deformed and forces are not directly passed on to the inner packaging.
 - 1-2. Do not apply excessive vibration, shock, or pressure to the capacitor.
 - (1) When excessive mechanical shock or pressure is applied to a capacitor, chipping or cracking may occur in the ceramic body of the capacitor.
 - (2) When the sharp edge of an air driver, a soldering iron, tweezers, a chassis, etc. impacts strongly on the surface of the capacitor, the capacitor may crack and short-circuit.
 - 1-3. Do not use a capacitor to which excessive shock was applied by dropping, etc.
A capacitor dropped accidentally during processing may be damaged.

2. Characteristics Evaluation in the Actual System

1. Evaluate the capacitor in the actual system, to confirm that there is no problem with the performance and specification values in a finished product before using.
2. Since a voltage dependency and temperature dependency exists in the capacitance of high dielectric type ceramic capacitors, the capacitance may change depending on the operating conditions in the actual system. Therefore, be sure to evaluate the various characteristics, such as the leakage current and noise absorptivity, which will affect the capacitance value of the capacitor.
3. In addition, voltages exceeding the predetermined surge may be applied to the capacitor by the inductance in the actual system. Evaluate the surge resistance in the actual system as required.

<Applicable to NFM Series>

4. The effects of noise suppression can vary depending on the usage conditions, including differences in the circuit or IC to be used, the type of noise, the shape of the pattern to be mounted, and the mounting location. Be sure to verify the effect on the actual device in advance.

GRM

GR3

GRJ

GR4

GR7

GJM

GQM

GA2

GA3
GB

GA3
GD

GA3
GF

LLL

LLA

LLM

LLR

NFM

KRM

KR3

GMA

GMD

Notice

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[NMC0402X5R105K6.3TRPF](#) [NMC0402X5R224K6.3TRPF](#) [NMC0402X7R103J25TRPF](#) [NMC0402X7R153K16TRPF](#)
[NMC0402X7R392K50TRPF](#) [NMC0603NPO1R8C50TRPF](#) [NMC0603NPO201J50TRPF](#) [NMC0603NPO330G50TRPF](#)
[NMC0603X5R475M6.3TRPF](#) [NMC0805NPO220J100TRPF](#) [NMC0805NPO270J50TRPF](#) [NMC0805NPO681F50TRPF](#)
[NMC0805NPO820J50TRPF](#) [NMC1206X7R102K50TRPF](#) [NMC1210Y5V105Z50TRPLPF](#) [NMC-L0402NPO7R0C50TRPF](#) [NMC-](#)
[L0603NPO2R2B50TRPF](#) [NMC-P0805NPO221J500TRPLPF](#) [NMC-P1206X7R103K1KVTRPLPF](#) [NMC-Q0402NPO8R2D200TRPF](#)
[C1206C101J1GAC](#) [C1608C0G2A221J](#) [C1608X7R1E334K](#) [C2012C0G2A472J](#) [2220J2K00562KXT](#) [KHC201E225M76N0T00](#)
[1812J2K00332KXT](#) [CCR06CG153FSV](#) [CDR14BP471CJUR](#) [CDR31BX103AKWR](#) [CDR33BX683AKUS](#) [CGA2B2C0G1H010C](#)
[CGA2B2C0G1H040C](#) [CGA2B2C0G1H050C](#) [CGA2B2C0G1H060D](#) [CGA2B2C0G1H070D](#) [CGA2B2C0G1H120J](#) [CGA2B2C0G1H151J](#)
[CGA2B2C0G1H1R5C](#) [CGA2B2C0G1H2R2C](#) [CGA2B2C0G1H390J](#) [CGA2B2C0G1H391J](#) [CGA2B2C0G1H3R3C](#) [CGA2B2C0G1H680J](#)
[CGA2B2C0G1H6R8D](#)